

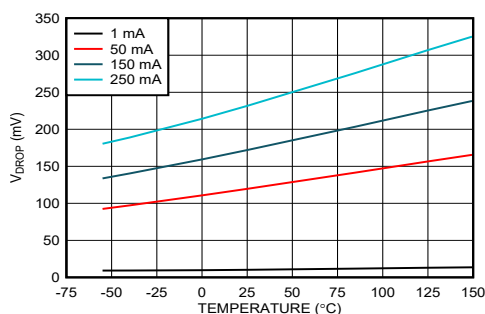
LP2992 マイクロパワー、250mA、低ノイズ、超低ドロップアウトレギュレータ、SOT-23 および WSON パッケージ、超低 ESR の出力コンデンサで使用するよう設計

1 特長

- V_{IN} 範囲 (新チップ): 2.5V~16V
- V_{OUT} 範囲 (新チップ):
 - 1.2V~5.0V (固定、100mV ステップ)
- V_{OUT} 精度:
 - $\pm 1\%$ (A グレードの従来チップ)
 - $\pm 1.5\%$ (標準グレードの従来チップ)
 - $\pm 0.5\%$ (新チップのみ)
- 負荷および温度の全範囲にわたって $\pm 1\%$ の出力精度 (新チップの場合)
- 出力電流: 最大 250 mA
- 低い I_Q (新チップ): 69 μ A ($I_{LOAD} = 0$ mA の場合)
- 低い I_Q (新チップ): 875 μ A ($I_{LOAD} = 250$ mA の場合)
- シャットダウン電流:
 - 0.01 μ A (標準値) (従来チップ)
 - 1.12 μ A (標準値) (新チップ)
- 低ノイズ: 30 μ V_{RMS} (10nF のバイパス・コンデンサを使用した場合)
- 出力電流制限および過熱保護
- 2.2 μ F のセラミック・コンデンサで安定動作
- 高い PSRR: 1kHz で 70dB、1MHz で 40dB
- 動作時接合部温度: -40°C~125°C
- パッケージ: 5 ピン SOT-23 (DBV)

2 アプリケーション

- 洗濯機 / 乾燥機
- 陸上移動無線
- アクティブ・アンテナ・システムの mMIMO
- コードレス電動工具
- モータ・ドライブおよび制御基板



新チップのドロップアウト電圧と温度との関係

3 概要

LP2992 は、固定出力で入力範囲の広い、低ノイズ、低ドロップアウトの電圧レギュレータで、2.5V~16V の入力電圧範囲に対応し、最大 250mA の負荷電流を供給できます。LP2992 は、1.2V~5.0V の出力範囲をサポートしています (新チップの場合)。

さらに、LP2992 (新チップ) は、負荷および温度の全範囲にわたって 1% の出力精度を備えており、低電圧マイクロコントローラ (MCU) およびプロセッサのニーズを満たすことができます。

30 μ V_{RMS} (10nF のバイパス・コンデンサを使用) の低い出力ノイズと、1kHz で 70dB、1MHz で 40dB を上回る広い帯域幅の PSRR 性能により、上流側 DC/DC コンバータのスイッチング周波数を低くすることができ、さらに、レギュレータ後のフィルタ処理を最小限に抑えることができます。

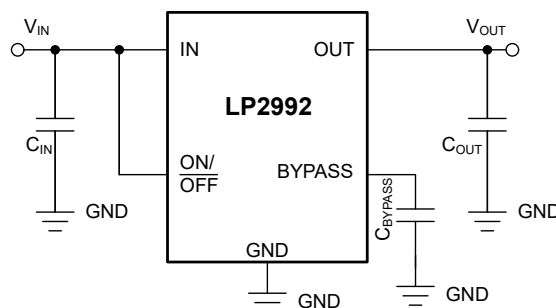
内部ソフトスタート時間および電流制限保護により、スタートアップ時の突入電流が減少し、入力静電容量を最小化しました。過電流および過熱保護などの一般的な保護機能を備えています。

LP2992 は、5 ピン、2.9mm × 2.8mm の SOT-23 (DBV) パッケージで供給されます。

パッケージ情報

部品番号	パッケージ (1)	パッケージ サイズ (2)
LP2992	DBV (SOT-23, 5)	2.9mm × 2.8mm
	WSON (6)	3.29 mm × 2.92 mm

- (1) 詳細については、[セクション 12](#) を参照してください。
- (2) パッケージ サイズ (長さ×幅) は公称値であり、該当する場合はピンも含まれます。



代表的なアプリケーション回路



Table of Contents

1 特長	1	7.1 Application Information.....	23
2 アプリケーション	1	7.2 Typical Application.....	25
3 概要	1	8 Power Supply Recommendations	27
4 Pin Configuration and Functions	3	9 Layout	28
5 Specifications	4	9.1 Layout Guidelines.....	28
5.1 Absolute Maximum Ratings.....	4	9.2 Layout Examples.....	28
5.2 ESD Ratings.....	4	10 Device and Documentation Support	29
5.3 Recommended Operating Conditions.....	4	10.1 Device Nomenclature.....	29
5.4 Electrical Characteristics.....	5	10.2 Documentation Support.....	29
5.5 Thermal Information.....	8	10.3 Receiving Notification of Documentation Updates..	29
5.6 Typical Characteristics.....	9	10.4 サポート・リソース.....	29
6 Detailed Description	19	10.5 Trademarks.....	29
6.1 Overview.....	19	10.6 静電気放電に関する注意事項.....	29
6.2 Functional Block Diagram.....	19	10.7 用語集.....	29
6.3 Feature Description.....	19	11 Revision History	30
6.4 Device Functional Modes.....	21	12 Mechanical, Packaging, and Orderable Information	30
7 Application and Implementation	23		

4 Pin Configuration and Functions

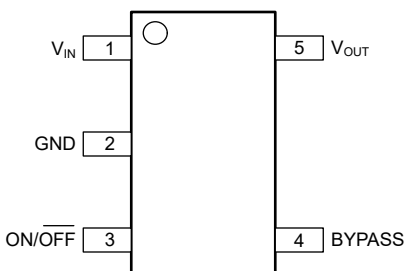


図 4-1. DBV Package, 5-Pin SOT-23 (Top View)

表 4-1. Pin Functions

PIN		TYPE	DESCRIPTION
NAME	NO.		
BYPASS	4	I/O	BYPASS pin to achieve low noise performance. Connecting an external capacitor between BYPASS pin and ground reduces reference voltage noise. See the セクション 5.3 section for more information.
GND	2	—	Ground
ON/OFF	3	I	Enable pin for the LDO. Driving the ON/OFF pin high enables the device. Driving this pin low disables the device. High and low thresholds are listed in the セクション 5.4 table. Tie this pin to V_{IN} if unused.
V_{IN}	1	I	Input supply pin. Use a capacitor with a value of 1 μF or larger from this pin to ground. See セクション 7.1.2 for more information.
V_{OUT}	5	O	Output of the regulator. Use a capacitor with a value of 2.2 μF or larger from this pin to ground ⁽¹⁾ . See the セクション 7.1.2 section for more information.

- (1) The nominal output capacitance must be greater than 1 μF . Throughout this document, the nominal derating on these capacitors is 50%. Make sure that the effective capacitance at the pin is greater than 1 μF .

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾ ⁽²⁾

		MIN	MAX	UNIT
V_{IN}	Continuous input voltage range (for legacy chip)	−0.3	16	V
	Continuous input voltage range (for new chip)	−0.3	18	
V_{OUT}	Output voltage range (for legacy chip)	−0.3	9	
	Output voltage range (for new chip)	−0.3	$V_{IN} + 0.3$ or 9 (whichever is smaller)	
V_{BYPASS}	BYPASS pin voltage range (for new chip)	−0.3	3	
$V_{ON/OFF}$	ON/OFF pin voltage range (for legacy chip)	−0.3	16	
	ON/OFF pin voltage range (for new chip)	−0.3	18	
Current	Maximum output	Internally limited		A
Temperature	Operating junction, T_J	−55	150	°C
		−65	150	

- (1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) All voltages with respect to GND.

5.2 ESD Ratings

			VALUE (Legacy Chip)	VALUE (New Chip)	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	±3000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±500	±1000	

- (1) JEDEC document JEP155 states that 2-kV HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 500-V CDM allows safe manufacturing with a standard ESD control process.

5.3 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
V_{IN}	Supply input voltage (for legacy chip)	2.2		16	V
	Supply input voltage (for new chip)	2.5		16	
V_{OUT}	Output voltage (for legacy chip)	1.2		10.0	
	Output voltage (for new chip)	1.2		5.0	
V_{BYPASS}	Bypass voltage		1.2		
$V_{ON/OFF}$	Enable voltage (for legacy chip)	0		V_{IN}	
	Enable voltage (for new chip)	0		16	
I_{OUT}	Output current	0		250	mA
C_{IN} ⁽¹⁾	Input capacitor		1		μF
C_{OUT}	Output capacitor (for legacy chip)	2.2	4.7		μF
	Output capacitance (for new chip) ⁽¹⁾	1	2.2	200	
T_J	Operating junction temperature	−40		125	°C

- (1) All capacitor values are assumed to derate to 50% of the nominal capacitor value. Maintain an effective output capacitance of 1 μF minimum for stability.

5.4 Electrical Characteristics

specified at $T_J = 25^\circ\text{C}$, $V_{IN} = V_{OUT(nom)} + 1.0\text{ V}$ or $V_{IN} = 2.5\text{ V}$ (whichever is greater), $I_{OUT} = 1\text{ mA}$, $V_{ON/OFF} = 2\text{ V}$, $C_{IN} = 1.0\text{ }\mu\text{F}$, and $C_{OUT} = 2.2\text{ }\mu\text{F}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
ΔV_{OUT}	Output voltage tolerance	$I_L = 1\text{ mA}$	Legacy chip (standard grade)	−1.5		1.5	%
			Legacy chip (A grade)	−1.0		1.0	
			New chip	−0.5		0.5	
		$1\text{ mA} \leq I_L \leq 50\text{ mA}$	Legacy chip (standard grade)	−2.5		2.5	
			Legacy chip (A grade)	−1.5		1.5	
			New chip	−0.5		0.5	
		$1\text{ mA} \leq I_L \leq 50\text{ mA}, -40^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$	Legacy chip (standard grade)	−3.5		3.5	
			Legacy chip (A grade)	−2.5		2.5	
			New chip	−1		1	
		$1\text{ mA} \leq I_L \leq 250\text{ mA}$	Legacy chip (standard grade)	−4		4	
			Legacy chip (A grade)	−3.5		3.5	
			New chip	−0.5		0.5	
		$1\text{ mA} \leq I_L \leq 250\text{ mA}, -40^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$	Legacy chip (standard grade)	−5		5	
			Legacy chip (A grade)	−4.5		4.5	
			New chip	−1		1	
$\Delta V_{OUT(\Delta V_{IN})}$	Line regulation	$V_{O(NOM)} + 1\text{ V} \leq V_{IN} \leq 16\text{ V}$	Legacy chip	0.007	0.014	% / V	
			New chip	0.002	0.014		
		$V_{O(NOM)} + 1\text{ V} \leq V_{IN} \leq 16\text{ V}, -40^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$	Legacy chip	0.007	0.032		
			New chip	0.002	0.032		
$V_{IN(MIN)}$	Minimum input voltage required to maintain output regulation		Legacy chip	2.05	V		
			New chip	2.05			
	Minimum input voltage required to maintain output regulation	$-40^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$	Legacy chip	2.2			
			New chip	2.35			

5.4 Electrical Characteristics (続き)

specified at $T_J = 25^\circ\text{C}$, $V_{IN} = V_{OUT(nom)} + 1.0\text{ V}$ or $V_{IN} = 2.5\text{ V}$ (whichever is greater), $I_{OUT} = 1\text{ mA}$, $V_{ON/OFF} = 2\text{ V}$, $C_{IN} = 1.0\text{ }\mu\text{F}$, and $C_{OUT} = 2.2\text{ }\mu\text{F}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
I_{GND}	GND pin current	$I_{OUT} = 0\text{ mA}$	Legacy chip	65	95		μA
			New chip	69	95		
		$I_{OUT} = 0\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	Legacy chip		125		
			New chip		123		
		$I_{OUT} = 1\text{ mA}$	Legacy chip	75	110		
			New chip	78	110		
		$I_{OUT} = 1\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	Legacy chip		170		
			New chip		140		
		$I_{OUT} = 50\text{ mA}$	Legacy chip	350	600		
			New chip	380	440		
		$I_{OUT} = 50\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	Legacy chip		1000		
			New chip		650		
		$I_{OUT} = 150\text{ mA}$	Legacy chip	850	1500		
			New chip	765	890		
		$I_{OUT} = 150\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	Legacy chip		2500		
			New chip		1060		
		$I_{OUT} = 250\text{ mA}$	Legacy Chip	1500	2300		
			New Chip	875	1010		
		$I_{OUT} = 250\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	Legacy Chip		4000		
			New Chip		1200		
		$V_{ON/OFF} < 0.3\text{ V}, V_{IN} = 16\text{ V}$	Legacy chip	0.01	0.8		
			New chip	1.25	1.75		
		$V_{ON/OFF} < 0.15\text{ V}, V_{IN} = 16\text{ V}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	Legacy chip	0.05	2		
			New chip	1.12	2.75		

5.4 Electrical Characteristics (続き)

specified at $T_J = 25^\circ\text{C}$, $V_{IN} = V_{OUT(nom)} + 1.0\text{ V}$ or $V_{IN} = 2.5\text{ V}$ (whichever is greater), $I_{OUT} = 1\text{ mA}$, $V_{ON/OFF} = 2\text{ V}$, $C_{IN} = 1.0\text{ }\mu\text{F}$, and $C_{OUT} = 2.2\text{ }\mu\text{F}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
V_{DO}	Dropout voltage ⁽¹⁾	$I_{OUT} = 0\text{ mA}$	Legacy chip	0.5	2.5		mV
			New chip	1	2.75		
		$I_{OUT} = 0\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	Legacy chip		4		
			New chip		3		
		$I_{OUT} = 1\text{ mA}$	Legacy chip		5	9	
			New chip		11.5	14	
		$I_{OUT} = 1\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	Legacy chip		12		
			New chip		17		
		$I_{OUT} = 50\text{ mA}$	Legacy chip		100	125	
			New chip		120	145	
		$I_{OUT} = 50\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	Legacy chip		180		
			New chip		184		
		$I_{OUT} = 150\text{ mA}$	Legacy chip		260	325	
			New chip		180	198	
		$I_{OUT} = 150\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	Legacy chip		470		
			New chip		254		
$V_{ON/OFF}$	ON/OFF input voltage	Low = Output OFF	Legacy chip	0.55			V
			New chip	0.72			
		Low = Output OFF, $V_{OUT} + 1 \leq V_{IN} \leq 16\text{ V}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	Legacy chip		0.15		
			New chip		0.15		
		High = Output ON	Legacy chip		1.4		
			New chip		0.85		
		High = Output ON, $V_{OUT} + 1 \leq V_{IN} \leq 16\text{ V}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	Legacy chip	1.6			
			New chip	1.6			
$I_{ON/OFF}$	ON/OFF input current	$V_{ON/OFF} = 0\text{ V}, V_{OUT} + 1 \leq V_{IN} \leq 16\text{ V}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	Legacy chip			-2	μA
			New chip			-0.9	
$I_{ON/OFF}$	ON/OFF input current	$V_{ON/OFF} = 0\text{ V}$	Legacy chip		0.01		μA
			New chip		0.42		
$IO(PK)$	Peak output current	$V_{OUT} \geq V_{O(NOM)} - 5\%$ (steady state)	Legacy chip	300	350		mA
			New chip	300	350		
$I_{O(SC)}$	Short output current	$R_L = 0\text{ }\Omega$ (steady state)	Legacy chip		400		
			New chip		375		
$\Delta V_O/\Delta V_{IN}$	Ripple rejection	$f = 1\text{ kHz}, C_{BYPASS} = 10\text{ nF}, C_{OUT} = 10\text{ }\mu\text{F}$	Legacy chip		45		dB
			New chip		78		
V_n	Output noise voltage	Bandwidth = 300 Hz to 50 kHz, $C_{BYPASS} = 10\text{ nF}, C_{OUT} = 2.2\text{ }\mu\text{F}, V_{OUT} = 3.3\text{ V}$	Legacy chip		30		μVRMS
			New chip		30		

(1) Dropout voltage (V_{DO}) is defined as the input-to-output differential at which the output voltage drops 100 mV below the value measured with a 1 V differential. V_{DO} is measured with $V_{IN} = V_{OUT(nom)} - 100\text{ mV}$ for fixed output devices.

5.5 Thermal Information

THERMAL METRIC ⁽¹⁾		Legacy Chip ⁽²⁾	New Chip ⁽²⁾	UNIT
		DBV (SOT23-5)	DBV (SOT23-5)	
		5 PINS	5 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	169.7	178.6	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	122.6	77.9	°C/W
R _{θJB}	Junction-to-board thermal resistance	29.9	47.2	°C/W
ψ _{JT}	Junction-to-top characterization parameter	16.7	15.9	°C/W
ψ _{JB}	Junction-to-board characterization parameter	29.4	46.9	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application note.
- (2) Thermal performance results are based on the JEDEC standard of 2s2p PCB configuration. These thermal metric parameters can be further improved by 35-55% based on thermally optimized PCB layout designs. See the analysis of the [Impact of board layout on LDO thermal performance](#) application report.

5.6 Typical Characteristics

$C_{IN} = 1\ \mu\text{F}$, $C_{OUT} = 4.7\ \mu\text{F}$, $V_{IN} = V_{OUT(NOM)} + 1\ \text{V}$, $T_A = 25^\circ\text{C}$, ON/OFF pin is tied to the IN pin (unless otherwise noted)

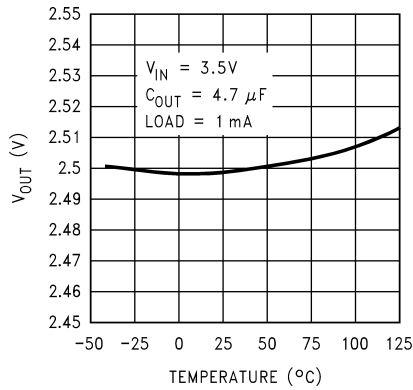
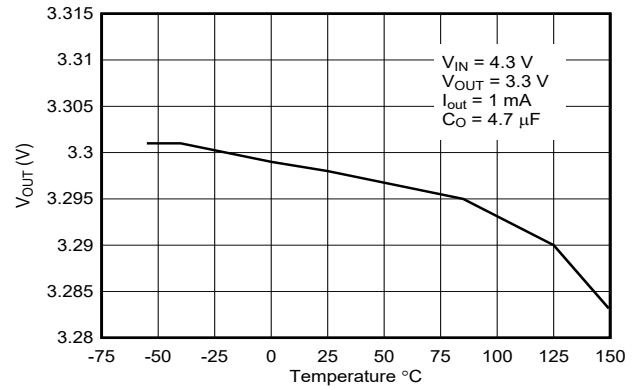


図 5-1. V_{OUT} vs Temperature for Legacy Chip



$V_{IN} = 4.3\ \text{V}$, $V_{OUT} = 3.3\ \text{V}$ (for new chip)

図 5-2. V_{OUT} vs Temperature for New Chip

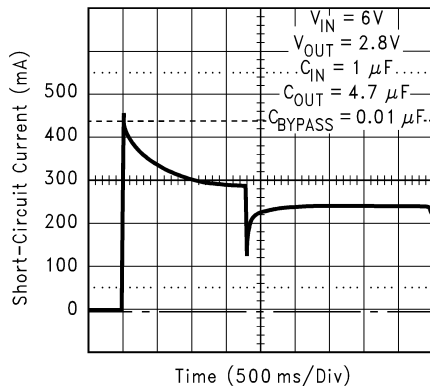


図 5-3. Short-Circuit Current for Legacy Chip

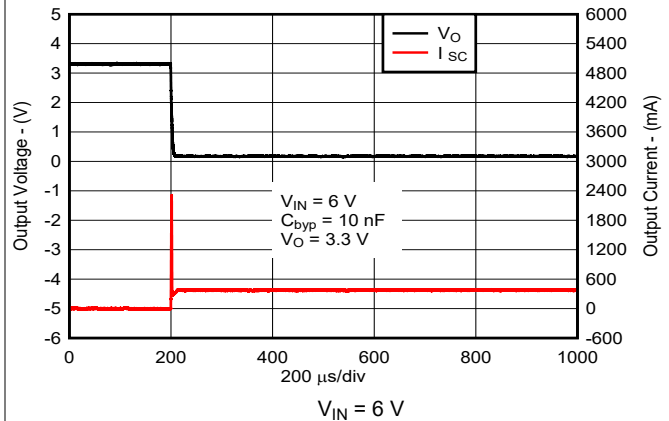


図 5-4. Short-Circuit Current vs Time for New Chip

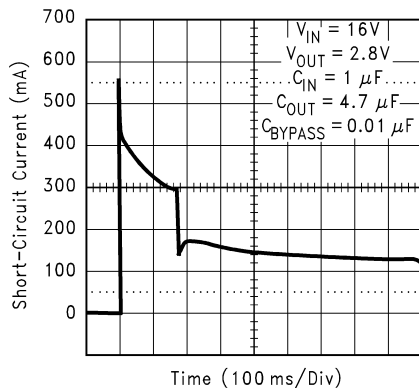


図 5-5. Short-Circuit Current for Legacy Chip

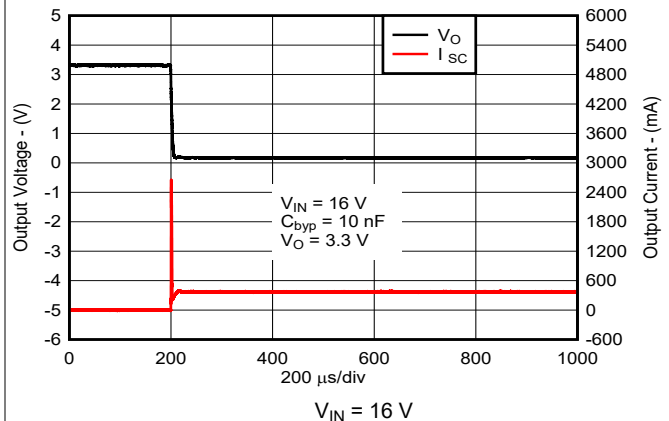


図 5-6. Short-Circuit Current vs Time for New Chip

5.6 Typical Characteristics (continued)

$C_{IN} = 1 \mu F$, $C_{OUT} = 4.7 \mu F$, $V_{IN} = V_{OUT(NOM)} + 1 V$, $T_A = 25^\circ C$, ON/OFF pin is tied to the IN pin (unless otherwise noted)

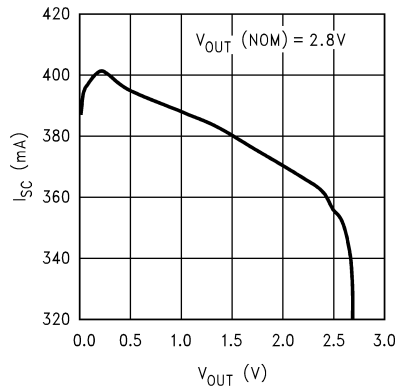


Figure 5-7. Short-Circuit Current vs Output Voltage for Legacy Chip

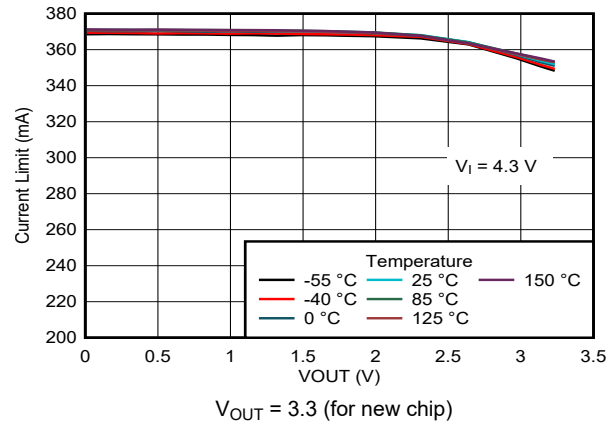


Figure 5-8. Short-Circuit Current vs Output Voltage for New Chip

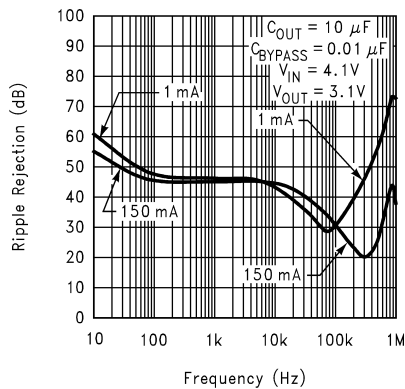


Figure 5-9. Ripple Rejection vs Frequency for Legacy Chip

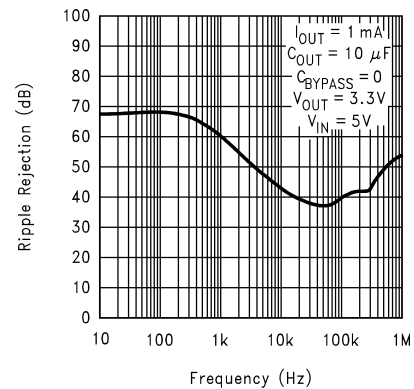


Figure 5-10. Ripple Rejection vs Frequency for Legacy Chip

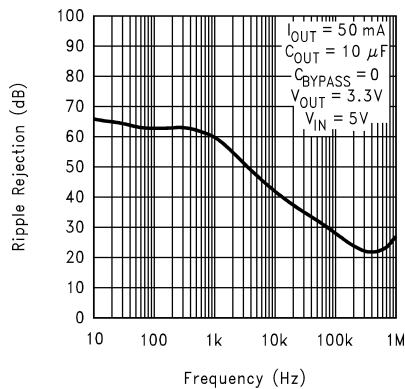


Figure 5-11. Ripple Rejection vs Frequency for Legacy Chip

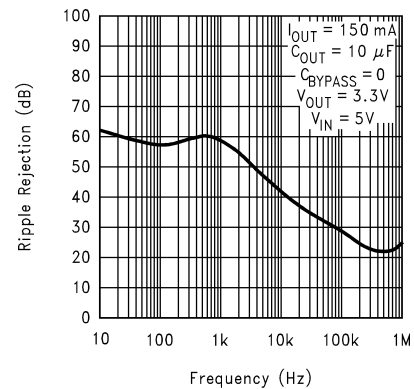
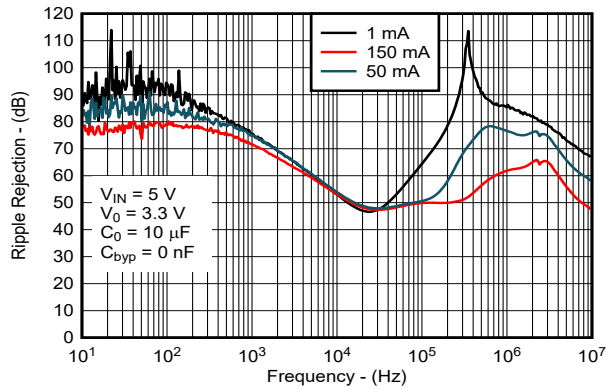


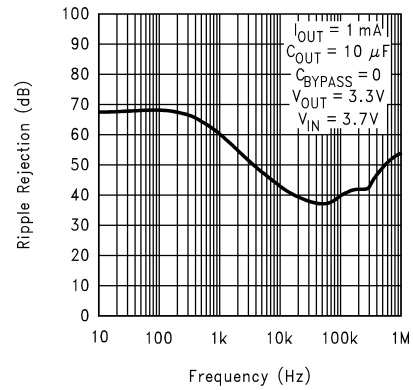
Figure 5-12. Ripple Rejection vs Frequency for Legacy Chip

5.6 Typical Characteristics (continued)

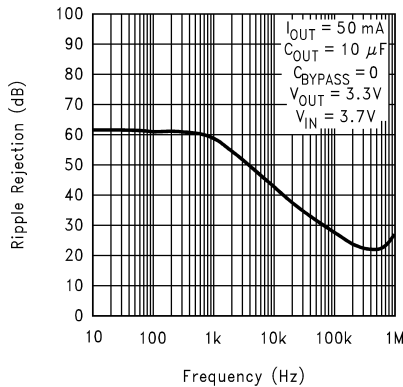
$C_{IN} = 1 \mu F$, $C_{OUT} = 4.7 \mu F$, $V_{IN} = V_{OUT(NOM)} + 1 V$, $T_A = 25^\circ C$, ON/OFF pin is tied to the IN pin (unless otherwise noted)



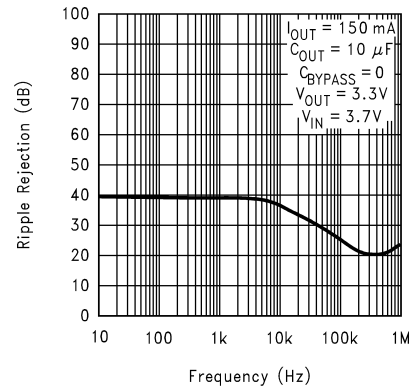
5-13. Ripple Rejection vs Frequency for New Chip



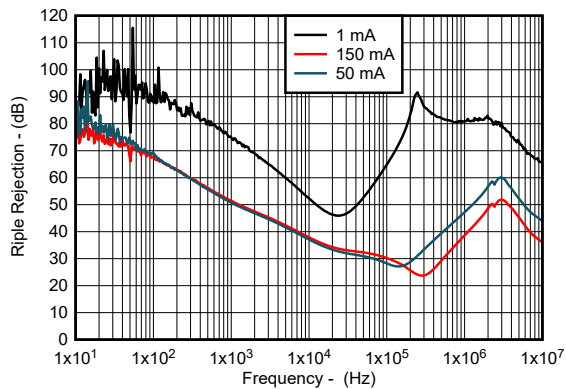
5-14. Ripple Rejection vs Frequency for Legacy Chip



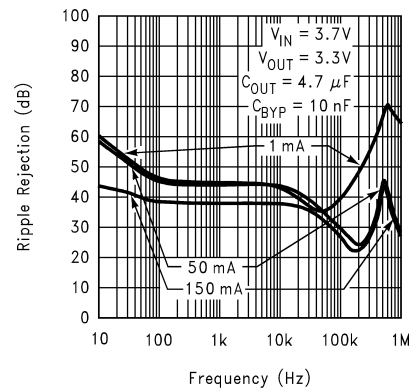
5-15. Ripple Rejection vs Frequency for Legacy Chip



5-16. Ripple Rejection vs Frequency for Legacy Chip



5-17. Ripple Rejection vs Frequency for New Chip



5-18. Ripple Rejection vs Frequency for Legacy Chip

5.6 Typical Characteristics (continued)

$C_{IN} = 1 \mu\text{F}$, $C_{OUT} = 4.7 \mu\text{F}$, $V_{IN} = V_{OUT(NOM)} + 1 \text{ V}$, $T_A = 25^\circ\text{C}$, ON/OFF pin is tied to the IN pin (unless otherwise noted)

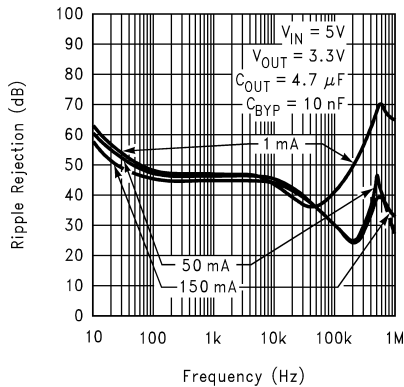
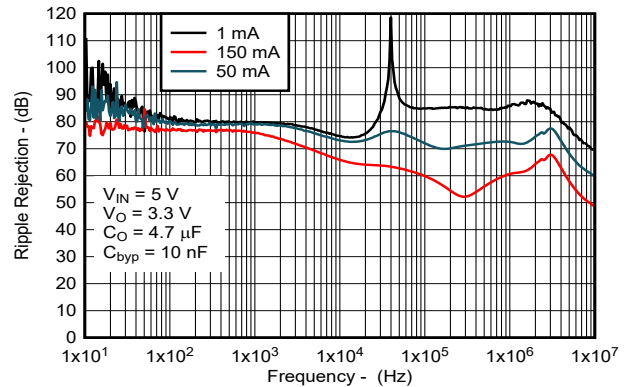


Figure 5-19. Ripple Rejection vs Frequency for Legacy Chip



$V_{IN} = 5 \text{ V}$, $V_{OUT} = 3.3 \text{ V}$, $C_{OUT} = 10 \mu\text{F}$, $C_{BYP} = 10 \text{ nF}$

Figure 5-20. Ripple Rejection vs Frequency for New Chip

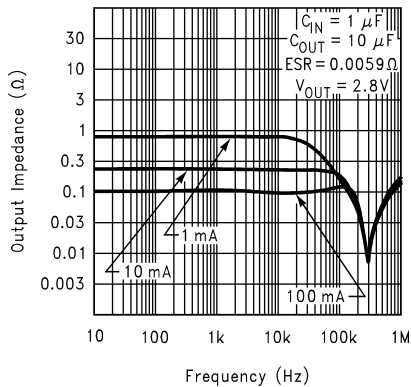


Figure 5-21. Output Impedance vs Frequency for Legacy Chip

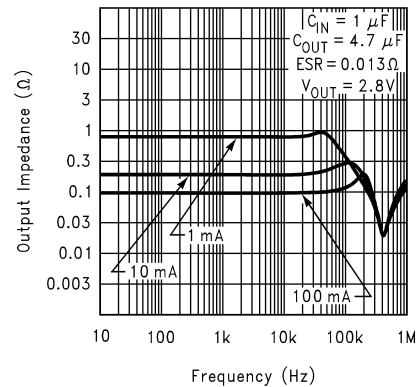


Figure 5-22. Output Impedance vs Frequency for Legacy Chip

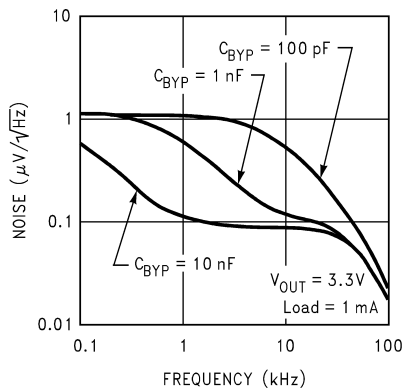


Figure 5-23. Output Noise Density for Legacy Chip

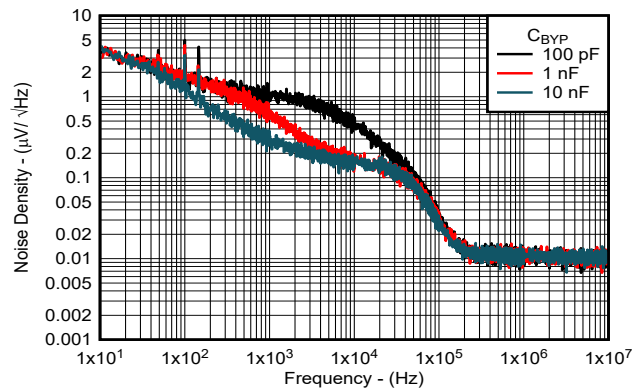


Figure 5-24. Output Noise Density vs Frequency for New Chip

5.6 Typical Characteristics (continued)

$C_{IN} = 1 \mu F$, $C_{OUT} = 4.7 \mu F$, $V_{IN} = V_{OUT(NOM)} + 1 V$, $T_A = 25^\circ C$, ON/OFF pin is tied to the IN pin (unless otherwise noted)

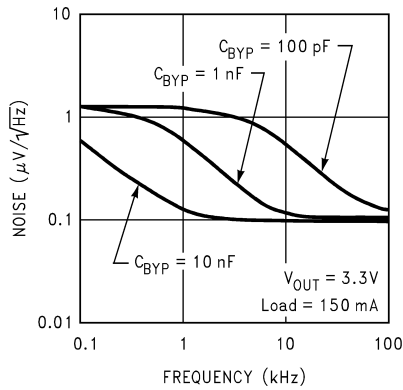


FIG 5-25. Output Noise Density for Legacy Chip

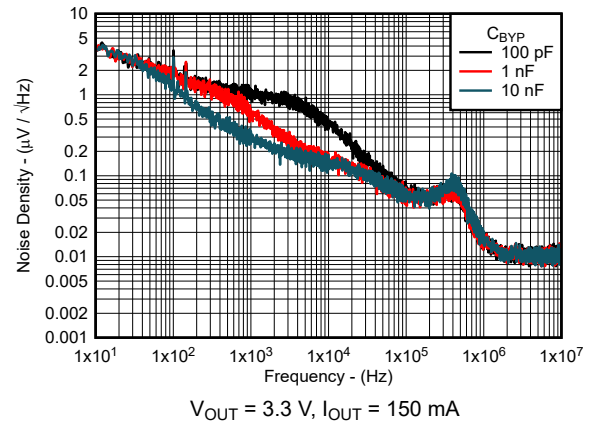


FIG 5-26. Output Noise Density vs Frequency for New Chip

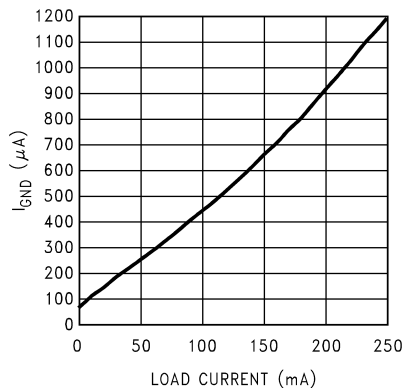


FIG 5-27. GND Pin vs Load Current for Legacy Chip

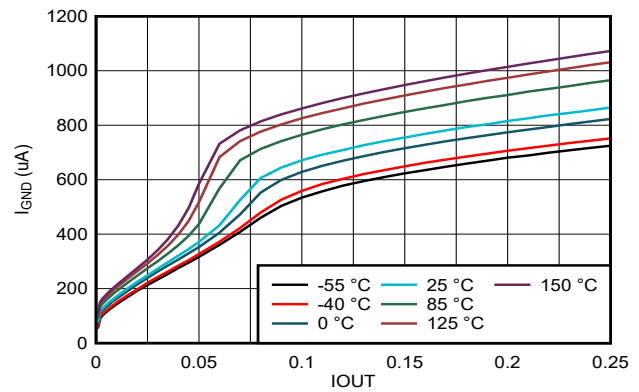


FIG 5-28. GND Pin vs Load Current for New Chip

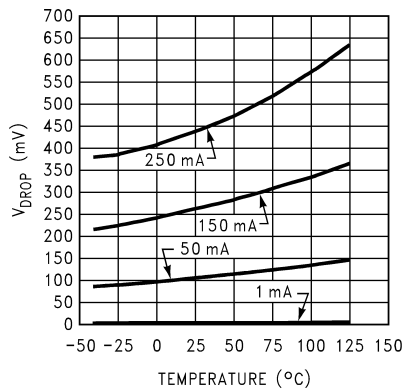


FIG 5-29. Dropout Voltage vs Temperature for Legacy Chip

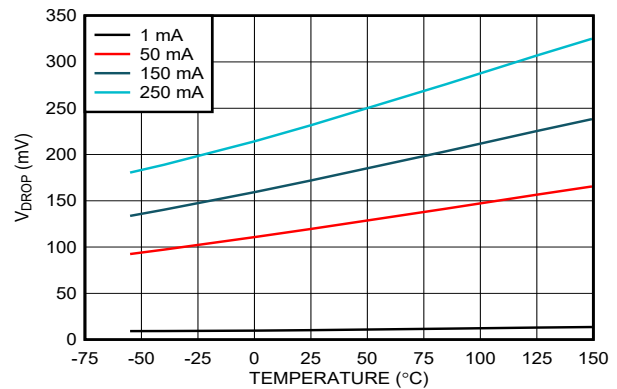


FIG 5-30. Dropout Voltage vs Temperature for New Chip

5.6 Typical Characteristics (continued)

$C_{IN} = 1 \mu F$, $C_{OUT} = 4.7 \mu F$, $V_{IN} = V_{OUT(NOM)} + 1 V$, $T_A = 25^\circ C$, ON/OFF pin is tied to the IN pin (unless otherwise noted)

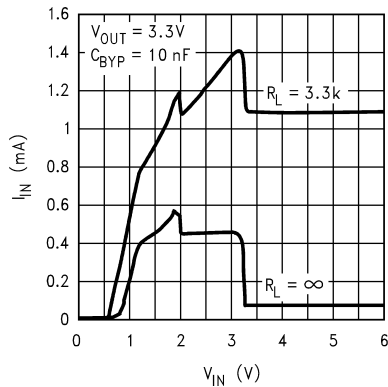


Figure 5-31. Input Current vs Input Voltage for Legacy Chip

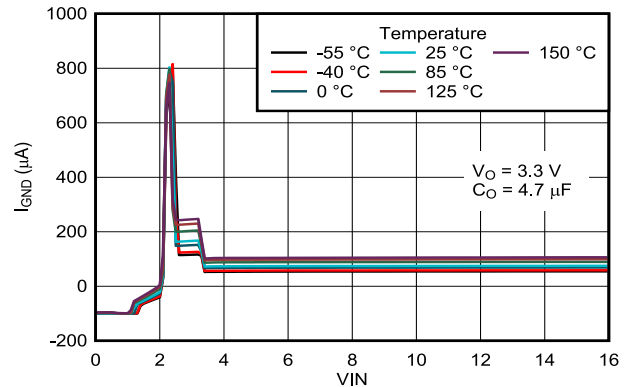


Figure 5-32. Input Current vs Input Voltage for New Chip

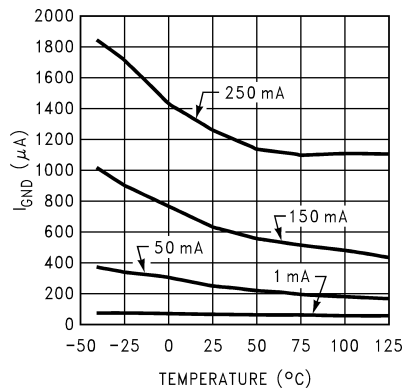


Figure 5-33. I_{GND} vs Load and Temperature for Legacy Chip

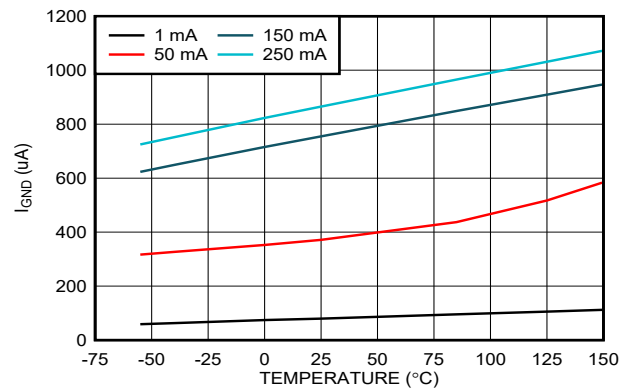


Figure 5-34. I_{GND} vs Load and Temperature for New Chip

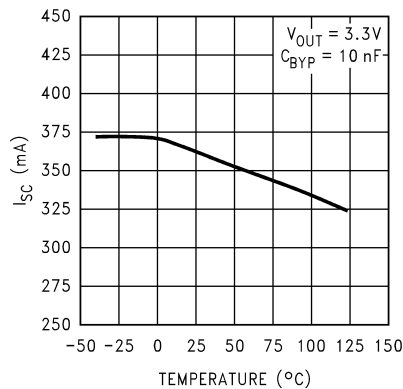


Figure 5-35. Short-Circuit Current vs Temperature for Legacy Chip

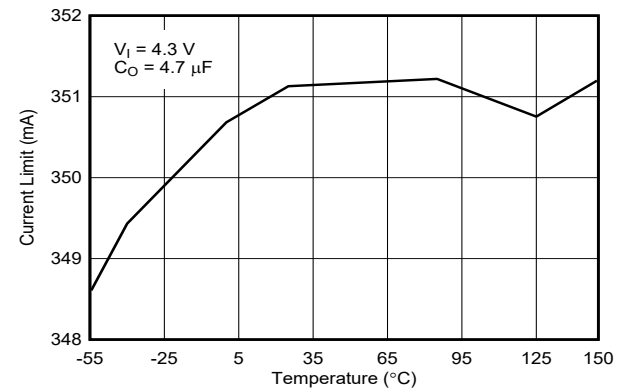
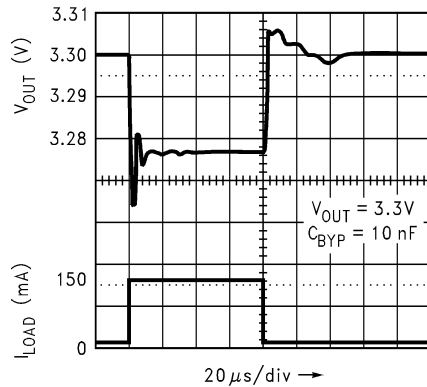


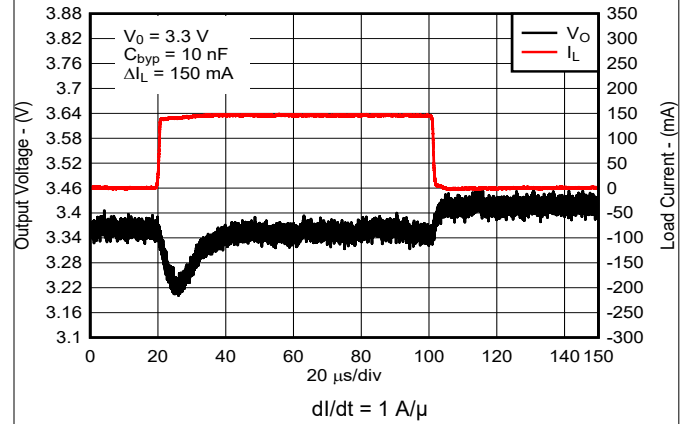
Figure 5-36. Short-Circuit Current vs Temperature for New Chip

5.6 Typical Characteristics (continued)

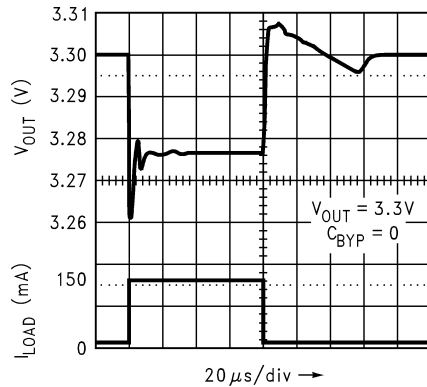
$C_{IN} = 1 \mu F$, $C_{OUT} = 4.7 \mu F$, $V_{IN} = V_{OUT(NOM)} + 1 V$, $T_A = 25^\circ C$, ON/OFF pin is tied to the IN pin (unless otherwise noted)



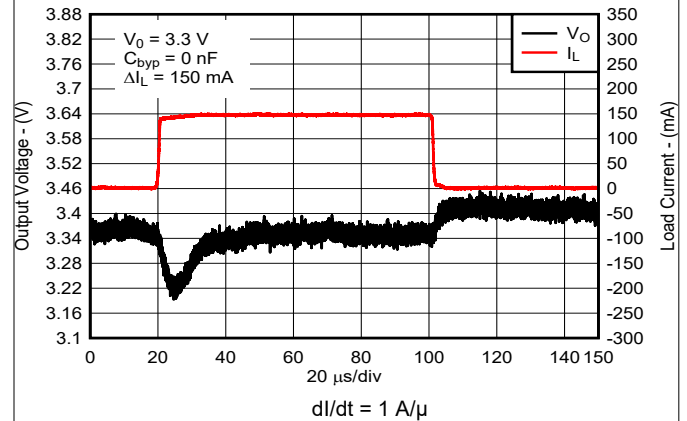
5-37. Load Transient Response for Legacy Chip



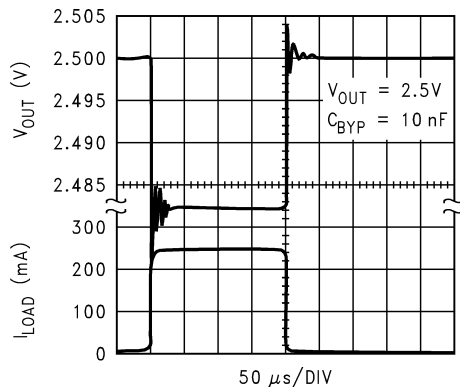
5-38. Load Transient for New Chip



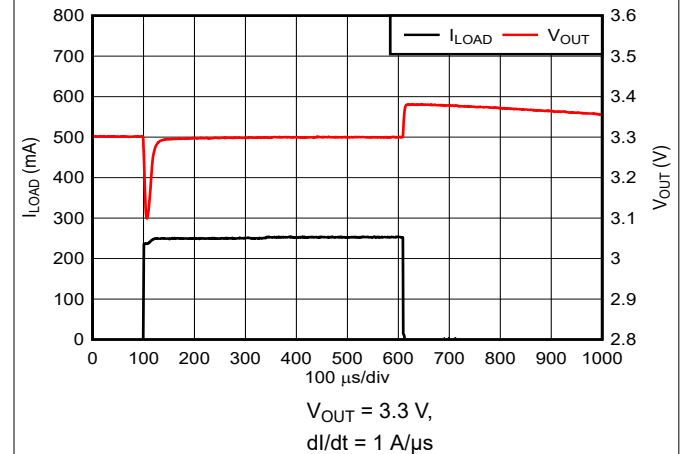
5-39. Load Transient Response for Legacy Chip



5-40. Load Transient Response for New Chip



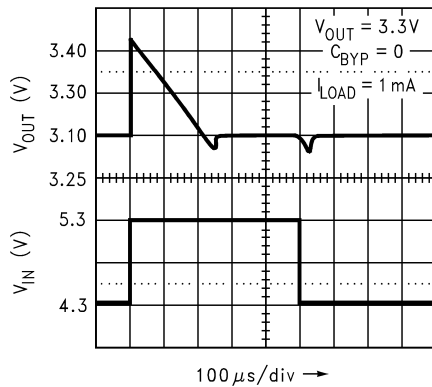
5-41. Load Transient Response for Legacy Chip



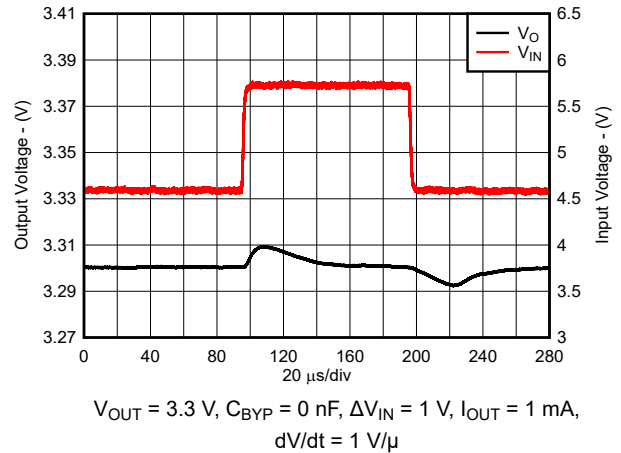
5-42. Load Transient Response for New Chip

5.6 Typical Characteristics (continued)

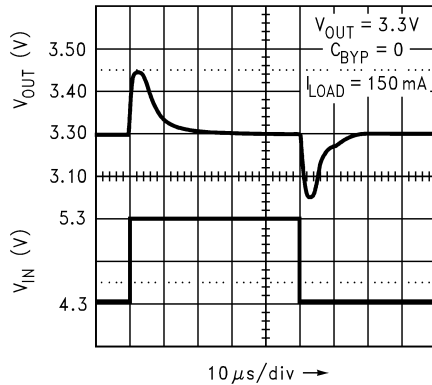
$C_{IN} = 1 \mu\text{F}$, $C_{OUT} = 4.7 \mu\text{F}$, $V_{IN} = V_{OUT(NOM)} + 1 \text{ V}$, $T_A = 25^\circ\text{C}$, ON/OFF pin is tied to the IN pin (unless otherwise noted)



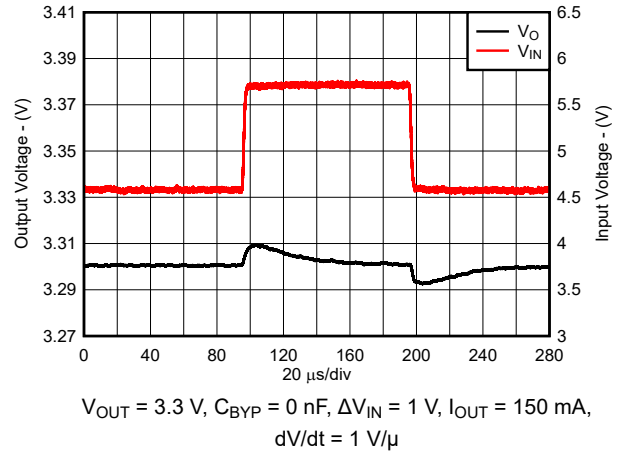
5-43. Line Transient Response for Legacy Chip



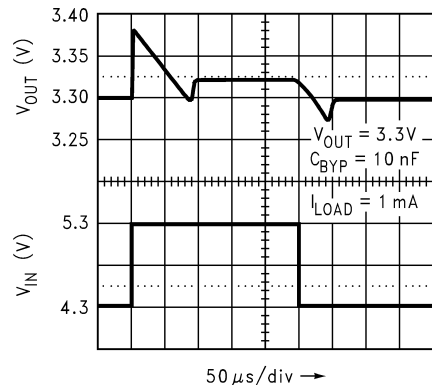
5-44. Line Transient Response for New Chip



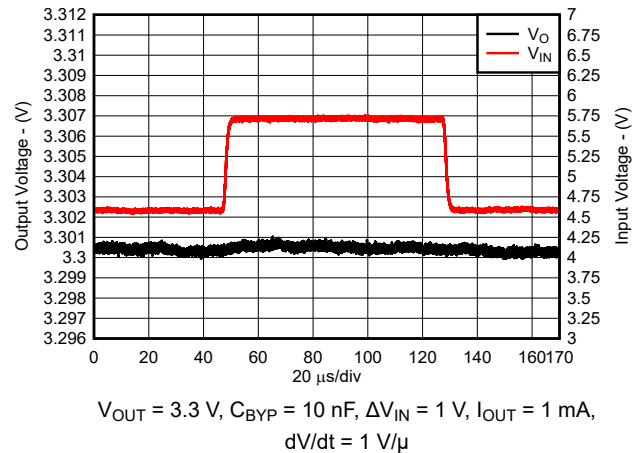
5-45. Line Transient Response for Legacy Chip



5-46. Line Transient Response for New Chip



5-47. Line Transient Response for Legacy Chip



5-48. Line Transient Response for New Chip

5.6 Typical Characteristics (continued)

$C_{IN} = 1 \mu\text{F}$, $C_{OUT} = 4.7 \mu\text{F}$, $V_{IN} = V_{OUT(NOM)} + 1 \text{ V}$, $T_A = 25^\circ\text{C}$, ON/OFF pin is tied to the IN pin (unless otherwise noted)

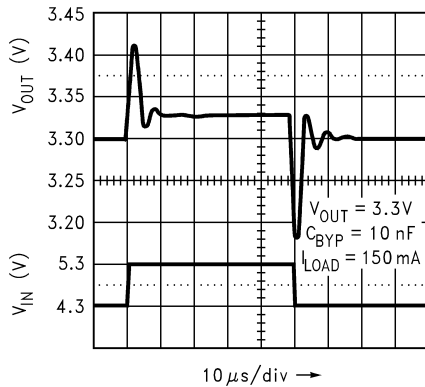


Figure 5-49. Line Transient Response for Legacy Chip

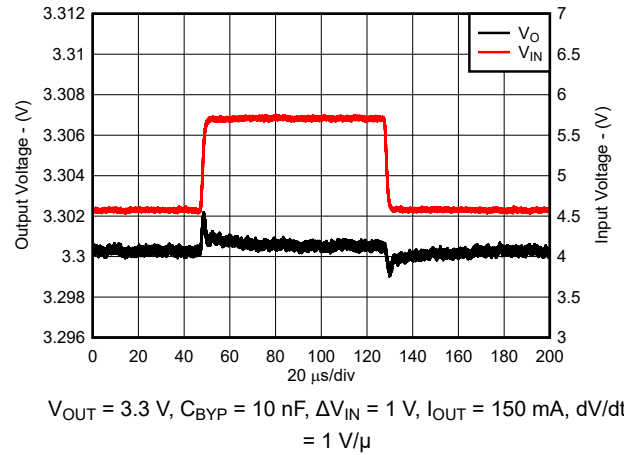


Figure 5-50. Line Transient Response for New Chip

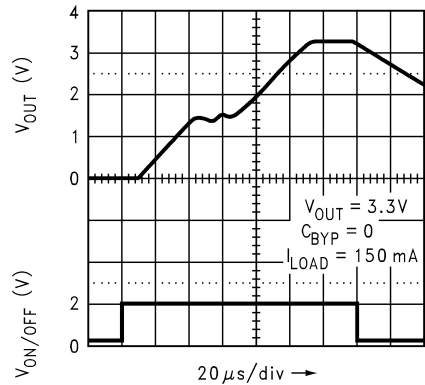


Figure 5-51. Turn-on Time for Legacy Chip

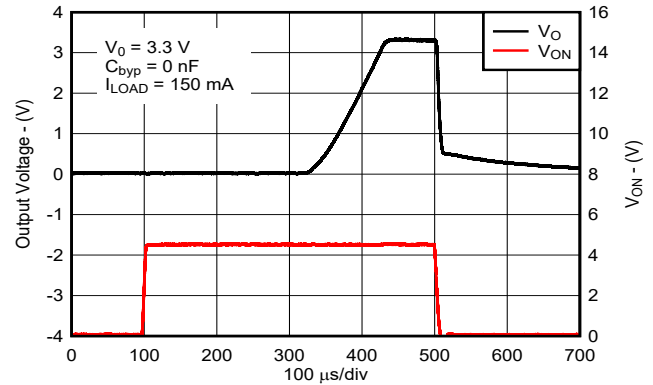


Figure 5-52. Turn-on Time for New Chip

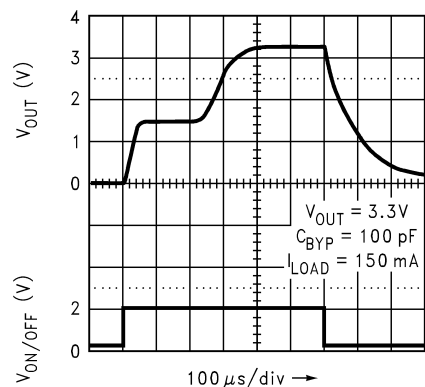


Figure 5-53. Turn-on Time for Legacy Chip

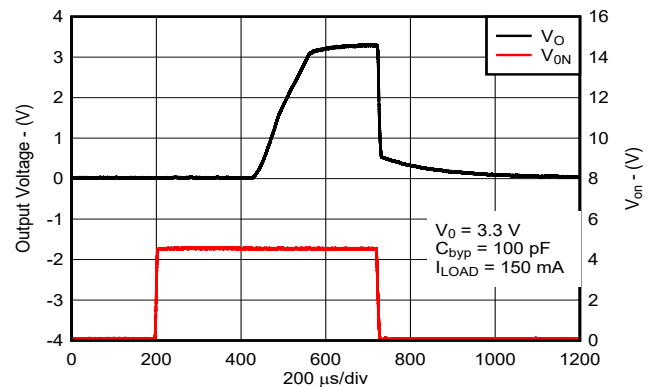
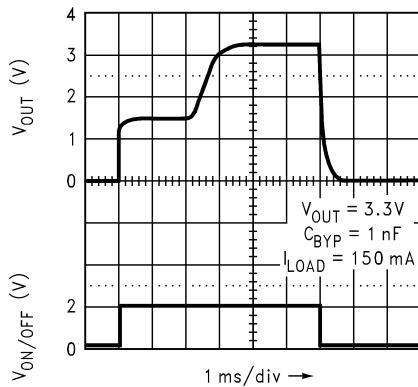


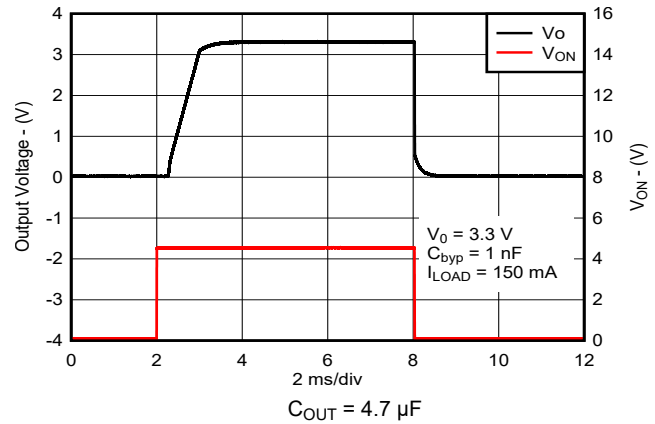
Figure 5-54. Turn-on Time for New Chip

5.6 Typical Characteristics (continued)

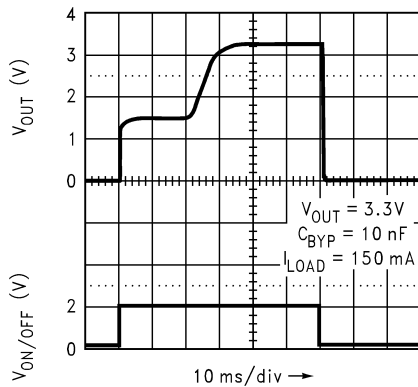
$C_{IN} = 1 \mu F$, $C_{OUT} = 4.7 \mu F$, $V_{IN} = V_{OUT(NOM)} + 1 V$, $T_A = 25^\circ C$, ON/OFF pin is tied to the IN pin (unless otherwise noted)



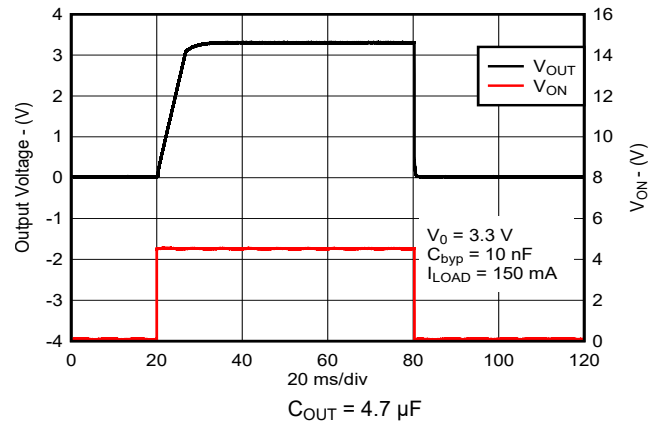
5-55. Turn-on Time for Legacy Chip



5-56. Turn-on Time for New Chip



5-57. Turn-on Time for Legacy Chip



5-58. Turn-on Time for New Chip

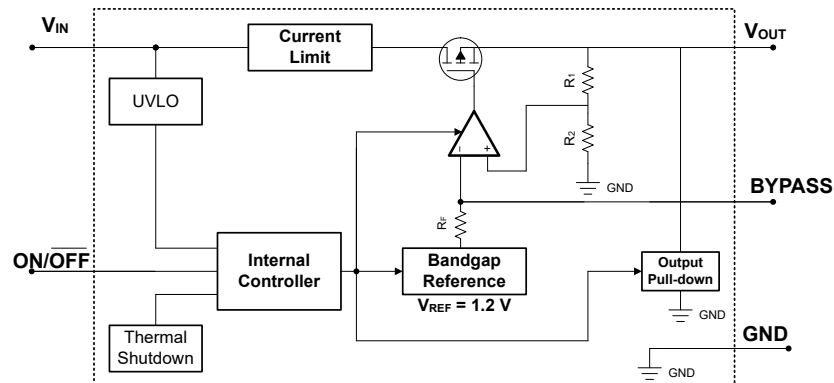
6 Detailed Description

6.1 Overview

The LP2991 is a fixed-output, low-noise, high PSRR, low-dropout regulator that offers exceptional, cost-effective performance for both portable and nonportable applications. The LP2991 has an output tolerance of 1% across line, load, and temperature variation (for the new chip) and is capable of delivering 250 mA of continuous load current.

This device features integrated overcurrent protection, thermal shutdown, output enable, and internal output pulldown and has a built-in soft-start mechanism for controlled inrush current. This device delivers excellent line and load transient performance. The operating ambient temperature range of the device is -40°C to 125°C .

6.2 Functional Block Diagram



6.3 Feature Description

6.3.1 Output Enable

The ON/ $\overline{\text{OFF}}$ pin for the device is an active-high pin. The output voltage is enabled when the voltage of the ON/ $\overline{\text{OFF}}$ pin is greater than the high-level input voltage of the ON/ $\overline{\text{OFF}}$ pin and disabled with the ON/ $\overline{\text{OFF}}$ pin voltage is less than the low-level input voltage of the ON/ $\overline{\text{OFF}}$ pin. If independent control of the output voltage is not needed, connect the ON/ $\overline{\text{OFF}}$ pin to the input of the device.

The device has an internal pulldown circuit that activates when the device is disabled by pulling the ON/ $\overline{\text{OFF}}$ pin voltage lower than the low-level input voltage of the ON/ $\overline{\text{OFF}}$ pin, to actively discharge the output voltage.

6.3.2 Dropout Voltage

Dropout voltage (V_{DO}) is defined as the input voltage minus the output voltage ($V_{\text{IN}} - V_{\text{OUT}}$) at the rated output current (I_{RATED}), where the pass transistor is fully on. I_{RATED} is the maximum I_{OUT} listed in the [セクション 5.3](#) table. The pass transistor is in the ohmic or triode region of operation, and acts as a switch. The dropout voltage indirectly specifies a minimum input voltage greater than the nominal programmed output voltage at which the output voltage is expected to stay in regulation. If the input voltage falls to less than the nominal output regulation, then the output voltage falls as well.

For a CMOS regulator, the dropout voltage is determined by the drain-source on-state resistance ($R_{DS(ON)}$) of the pass transistor. Therefore, if the linear regulator operates at less than the rated current, the dropout voltage for that current scales accordingly. The following equation calculates the $R_{DS(ON)}$ of the device.

$$R_{DS(ON)} = \frac{V_{DO}}{I_{RATED}} \quad (1)$$

6.3.3 Current Limit

The device has an internal current limit circuit that protects the regulator during transient high-load current faults or shorting events. The current limit is a brick-wall scheme. In a high-load current fault, the brick-wall scheme limits the output current to the current limit (I_{CL}). I_{CL} is listed in the [セクション 5.4](#) table.

The output voltage is not regulated when the device is in current limit. When a current limit event occurs, the device begins to heat up because of the increase in power dissipation. When the device is in brick-wall current limit, the pass transistor dissipates power $[(V_{IN} - V_{OUT}) \times I_{CL}]$. If thermal shutdown is triggered, the device turns off. After the device cools down, the internal thermal shutdown circuit turns the device back on. If the output current fault condition continues, the device cycles between current limit and thermal shutdown. For more information on current limits, see the [Know Your Limits](#) application note.

図 6-1 shows a diagram of the current limit.

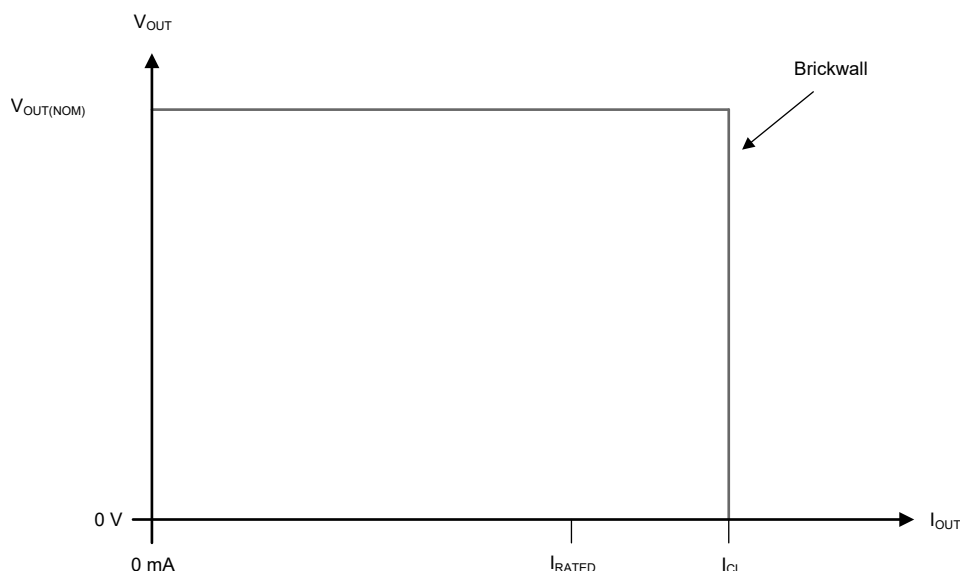


図 6-1. Current Limit

6.3.4 Undervoltage Lockout (UVLO)

The device has an independent undervoltage lockout (UVLO) circuit that monitors the input voltage, allowing a controlled and consistent turn on and off of the output voltage. To prevent the device from turning off if the input drops during turn on, the UVLO has hysteresis as specified in the [セクション 5.4](#) table.

6.3.5 Output Pulldown

The new chip has an output pulldown circuit. The output pulldown activates in the following conditions:

- When the device is disabled ($V_{ON/OFF} < V_{ON/OFF(LOW)}$)
- If $1.0\text{ V} < V_{IN} < V_{UVLO}$

Do not rely on the output pulldown circuit for discharging a large amount of output capacitance after the input supply has collapsed because reverse current can flow from the output to the input. This reverse current flow can cause damage to the device. See the [セクション 7.1.6](#) section for more details.

6.3.6 Thermal Shutdown

The device contains a thermal shutdown protection circuit to disable the device when the junction temperature (T_J) of the pass transistor rises to $T_{SD(shutdown)}$ (typical). Thermal shutdown hysteresis resets (turns on) the device when the temperature falls to $T_{SD(reset)}$ (typical).

The thermal time-constant of the semiconductor die is fairly short, thus the device can cycle on and off when thermal shutdown is reached until power dissipation is reduced. Power dissipation during start up can be high from large $V_{IN} - V_{OUT}$ voltage drops across the device or from high inrush currents charging large output capacitors. Under some conditions, the thermal shutdown protection disables the device before start up completes.

For reliable operation, limit the junction temperature to the maximum listed in the [セクション 5.3](#) table. Operation above this maximum temperature causes the device to exceed operational specifications. Although the internal protection circuitry of the device is designed to protect against thermal overall conditions, this circuitry is not intended to replace proper heat sinking. Continuously running the device into thermal shutdown or above the maximum recommended junction temperature reduces long-term reliability.

6.4 Device Functional Modes

6.4.1 Device Functional Mode Comparison

[表 6-1](#) shows the conditions that lead to the different modes of operation. See [セクション 5.4](#) for parameter values.

表 6-1. Device Functional Mode Comparison

OPERATING MODE	PARAMETER			
	V_{IN}	$V_{ON/OFF}$	I_{OUT}	T_J
Normal operation	$V_{IN} > V_{OUT(nom)} + V_{DO}$ and $V_{IN} > V_{IN(min)}$	$V_{ON/OFF} > V_{ON/OFF(HI)}$	$I_{OUT} < I_{OUT(max)}$	$T_J < T_{SD(shutdown)}$
Dropout operation	$V_{IN(min)} < V_{IN} < V_{OUT(nom)} + V_{DO}$	$V_{ON/OFF} > V_{ON/OFF(HI)}$	$I_{OUT} < I_{OUT(max)}$	$T_J < T_{SD(shutdown)}$
Disabled (any true condition disables the device)	$V_{IN} < V_{UVLO}$	$V_{ON/OFF} < V_{ON/OFF(LOW)}$	Not applicable	$T_J > T_{SD(shutdown)}$

6.4.2 Normal Operation

The device regulates to the nominal output voltage when the following conditions are met:

- The input voltage is greater than the nominal output voltage plus the dropout voltage ($V_{OUT(nom)} + V_{DO}$)
- The output current is less than the current limit ($I_{OUT} < I_{CL}$)
- The device junction temperature is less than the thermal shutdown temperature ($T_J < T_{SD}$)
- The ON/OFF voltage has previously exceeded the ON/OFF rising threshold voltage and has not yet decreased to less than the enable falling threshold

6.4.3 Dropout Operation

If the input voltage is lower than the nominal output voltage plus the specified dropout voltage, but all other conditions are met for normal operation, the device operates in dropout mode. In this mode, the output voltage tracks the input voltage. During this mode, the transient performance of the device becomes significantly degraded because the pass transistor is in the ohmic or triode region, and acts as a switch. Line or load transients in dropout can result in large output-voltage deviations.

When the device is in a steady dropout state (defined as when the device is in dropout, $V_{IN} < V_{OUT(NOM)} + V_{DO}$, directly after being in a normal regulation state, but *not* during start up), the pass transistor is driven into the ohmic or triode region. When the input voltage returns to a value greater than or equal to the nominal output voltage plus the dropout voltage ($V_{OUT(NOM)} + V_{DO}$), the output voltage can overshoot for a short period of time while the device pulls the pass transistor back into the linear region.

6.4.4 Disabled

The output of the device can be shutdown by forcing the voltage of the $ON/\overline{OFF}$ pin to less than the maximum $ON/\overline{OFF}$ pin low-level input voltage (see the [セクション 5.4](#) table). When disabled, the pass transistor is turned off, internal circuits are shutdown, and the output voltage is actively discharged to ground by an internal discharge circuit from the output to ground.

7 Application and Implementation

注

以下のアプリケーション情報は、TI の製品仕様に含まれるものではなく、TI ではその正確性または完全性を保証いたしません。個々の目的に対する製品の適合性については、お客様の責任で判断していただくことになります。お客様は自身の設計実装を検証しテストすることで、システムの機能を確認する必要があります。

7.1 Application Information

7.1.1 Estimating Junction Temperature

The JEDEC standard now recommends the use of psi (Ψ) thermal metrics to estimate the junction temperatures of the linear regulator when in-circuit on a typical PCB board application. These metrics are not thermal resistance parameters and instead offer a practical and relative way to estimate junction temperature. These psi metrics are determined to be significantly independent of the copper area available for heat-spreading. [セクション 5.5](#) lists the primary thermal metrics, which are the junction-to-top characterization parameter (ψ_{JT}) and junction-to-board characterization parameter (ψ_{JB}). These parameters provide two methods for calculating the junction temperature (T_J), as described in the following equations. Use the junction-to-top characterization parameter (ψ_{JT}) with the temperature at the center-top of device package (T_T) to calculate the junction temperature. Use the junction-to-board characterization parameter (ψ_{JB}) with the PCB surface temperature 1 mm from the device package (T_B) to calculate the junction temperature.

$$T_J = T_T + \psi_{JT} \times P_D \quad (2)$$

where:

- P_D is the dissipated power
- T_T is the temperature at the center-top of the device package

$$T_J = T_B + \psi_{JB} \times P_D \quad (3)$$

where:

- T_B is the PCB surface temperature measured 1 mm from the device package and centered on the package edge

For detailed information on the thermal metrics and how to use them, see the [Semiconductor and IC Package Thermal Metrics](#) application note.

7.1.2 Input and Output Capacitor Requirements

Although an input capacitor is not required for stability, good analog design practice is to connect a capacitor from IN to GND. This capacitor counteracts reactive input sources and improves transient response, input ripple, and PSRR. Use an input capacitor if the source impedance is more than 0.5 Ω . A higher value capacitor can be necessary if large, fast rise-time load or line transients are anticipated or if the device is located several inches from the input power source.

Dynamic performance of the device is improved with the use of an output capacitor. Use an output capacitor within the range specified in the [セクション 5.3](#) table for stability.

7.1.3 Noise Bypass Capacitor (C_{BYPASS})

The LP2992 allows for low-noise performance with the use of a bypass capacitor that is connected to the internal band-gap reference with the BYPASS pin. This high-impedance band-gap circuitry is biased in the microampere range and, thus, cannot be loaded significantly, otherwise, the output (and, correspondingly, the output of the regulator) changes. Thus, for best output accuracy, dc leakage current through C_{BYPASS} must be minimized as much as possible and must never exceed 100 nA. The C_{BYPASS} capacitor also impacts the start-up behavior of the regulator. Inrush current and start-up time increase with larger bypass capacitor values.

Use a 10-nF capacitor for C_{BYPASS} . Ceramic and film capacitors are good choices for this purpose.

7.1.4 Power Dissipation (P_D)

Circuit reliability requires consideration of the device power dissipation, location of the circuit on the printed circuit board (PCB), and correct sizing of the thermal plane. The PCB area around the regulator must have few or no other heat-generating devices that cause added thermal stress.

To first-order approximation, power dissipation in the regulator depends on the input-to-output voltage difference and load conditions. The following equation calculates power dissipation (P_D).

$$P_D = (V_{IN} - V_{OUT}) \times I_{OUT} \quad (4)$$

注

Power dissipation can be minimized, and therefore greater efficiency can be achieved, by correct selection of the system voltage rails. For the lowest power dissipation use the minimum input voltage required for correct output regulation.

For devices with a thermal pad, the primary heat conduction path for the device package is through the thermal pad to the PCB. Solder the thermal pad to a copper pad area under the device. This pad area must contain an array of plated vias that conduct heat to additional copper planes for increased heat dissipation.

The maximum power dissipation determines the maximum allowable ambient temperature (T_A) for the device. According to the following equation, power dissipation and junction temperature are most often related by the junction-to-ambient thermal resistance ($R_{\theta JA}$) of the combined PCB and device package and the temperature of the ambient air (T_A).

$$T_J = T_A + (R_{\theta JA} \times P_D) \quad (5)$$

Thermal resistance ($R_{\theta JA}$) is highly dependent on the heat-spreading capability built into the particular PCB design, and therefore varies according to the total copper area, copper weight, and location of the planes. The junction-to-ambient thermal resistance listed in [セクション 5.5](#) table is determined by the JEDEC standard PCB and copper-spreading area, and is used as a relative measure of package thermal performance.

7.1.5 Recommended Capacitor Types

The device is designed to be stable using low equivalent series resistance (ESR) ceramic capacitors at the input and output. Multilayer ceramic capacitors have become the industry standard for these types of applications and are recommended, but must be used with good judgment. Ceramic capacitors that employ X7R-, X5R-, and C0G-rated dielectric materials provide relatively good capacitive stability across temperature, whereas the use of Y5V-rated capacitors is discouraged because of large variations in capacitance.

Regardless of the ceramic capacitor type selected, the effective capacitance varies with operating voltage and temperature. Generally, expect the effective capacitance to decrease by as much as 50%. The input and output capacitors listed in [セクション 5.3](#) account for an effective capacitance of approximately 50% of the nominal value.

7.1.6 Reverse Current

Excessive reverse current can damage this device. Reverse current flows through the intrinsic body diode of the pass transistor instead of the normal conducting channel. At high magnitudes, this current flow degrades the long-term reliability of the device.

Conditions where reverse current can occur are outlined in this section, all of which can exceed the absolute maximum rating of $V_{OUT} \leq V_{IN} + 0.3 \text{ V}$.

- If the device has a large C_{OUT} and the input supply collapses with little or no load current
- The output is biased when the input supply is not established
- The output is biased above the input supply

If reverse current flow is expected in the application, use external protection to protect the device. Reverse current is not limited in the device, so external limiting is required if extended reverse voltage operation is anticipated.

Figure 7-1 shows one approach for protecting the device.

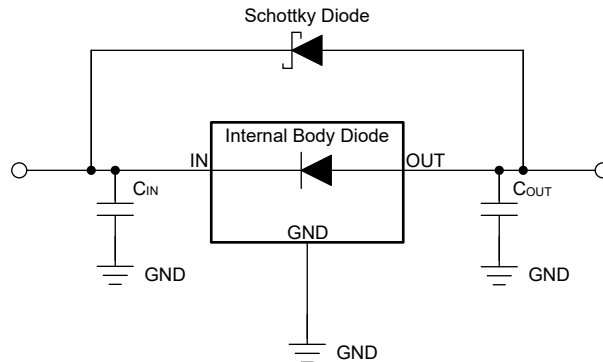


Figure 7-1. Example Circuit for Reverse Current Protection Using a Schottky Diode

7.2 Typical Application

Figure 7-2 shows the standard usage of the LP2992 as a low-dropout regulator.

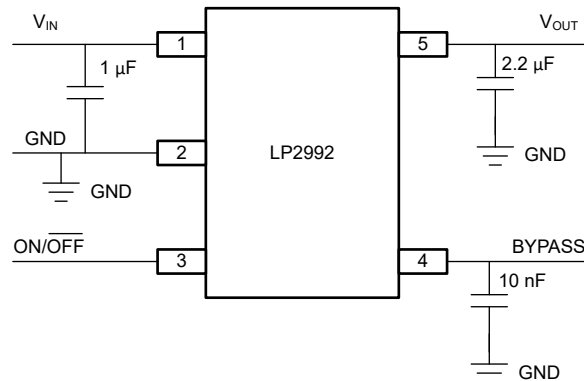


Figure 7-2. LP2992 Typical Application

7.2.1 Design Requirements

Minimum C_{OUT} value for stability (can be increased without limit for improved stability and transient response)

ON/OFF must be actively terminated. Connect to V_{IN} if shutdown feature is not used.

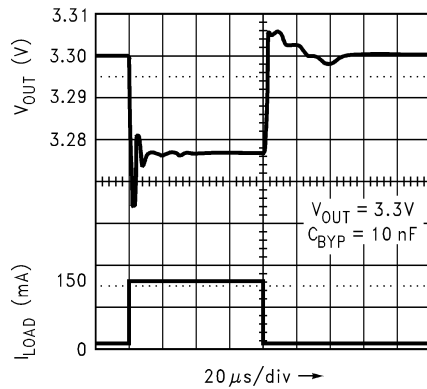
Optional BYPASS capacitor for low-noise operation.

7.2.2 Detailed Design Procedure

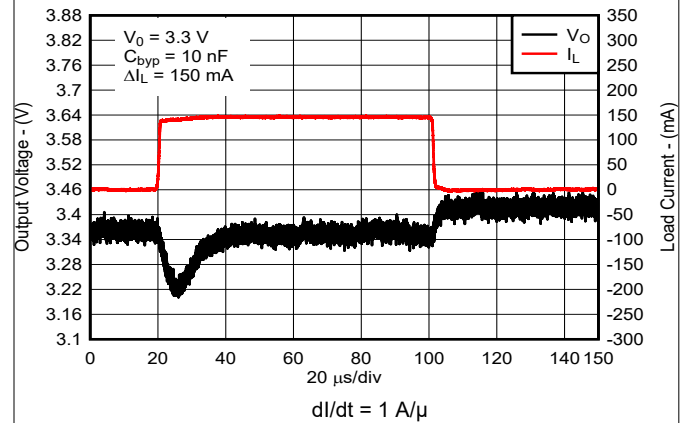
7.2.2.1 ON/OFF Operation

The LP2992 allows for a shutdown mode using the ON/OFF pin. Driving the pin LOW (≤ 0.4 V) turns the device OFF; conversely, a HIGH (≥ 1.2 V) turns the device ON. If the shutdown feature is not used, connect ON/OFF to the input so that the regulator is on at all times. For proper operation, do not leave ON/OFF unconnected.

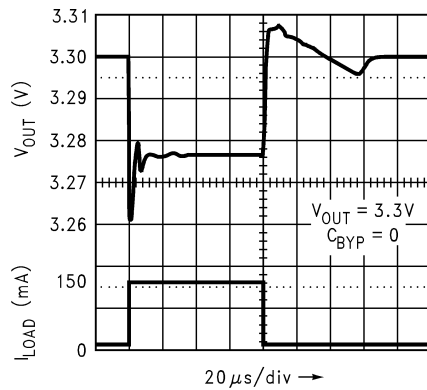
7.2.3 Application Curves



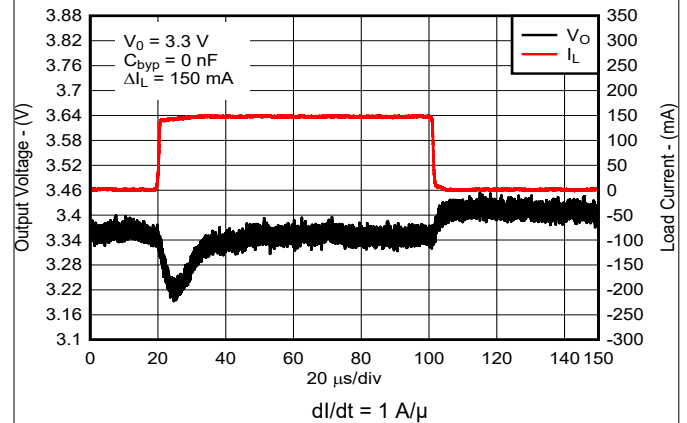
7-3. Load Transient Response for Legacy Chip



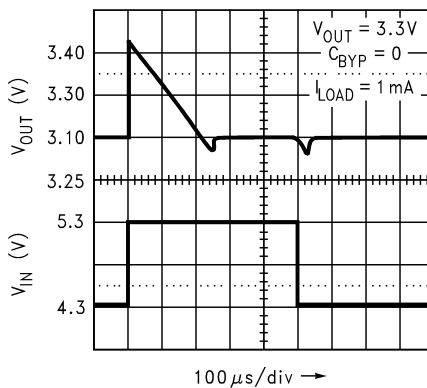
7-4. Load Transient for New Chip



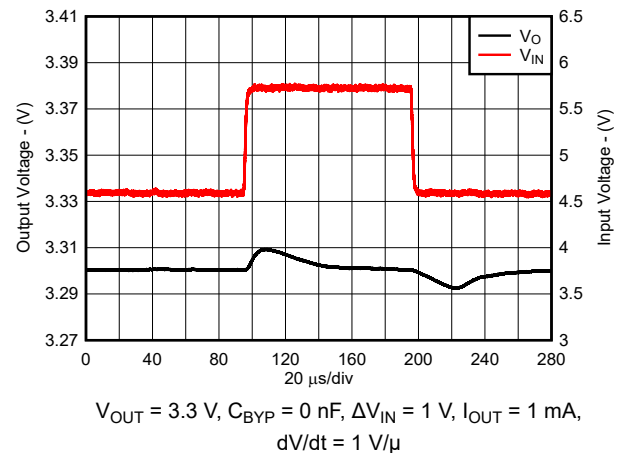
7-5. Load Transient Response for Legacy Chip



7-6. Load Transient Response for New Chip

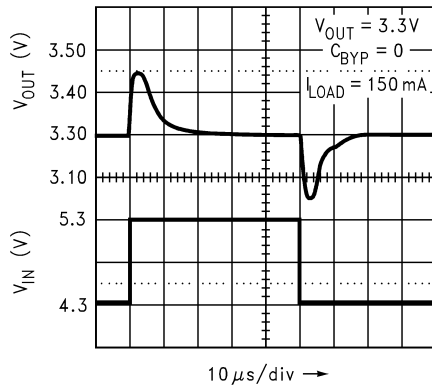


7-7. Line Transient Response for Legacy Chip

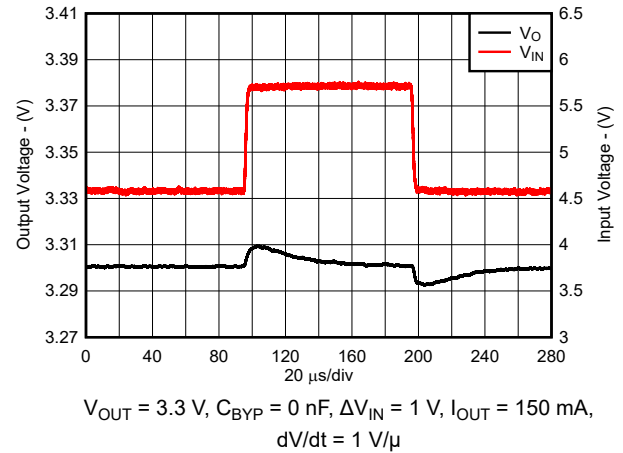


7-8. Line Transient Response for New Chip

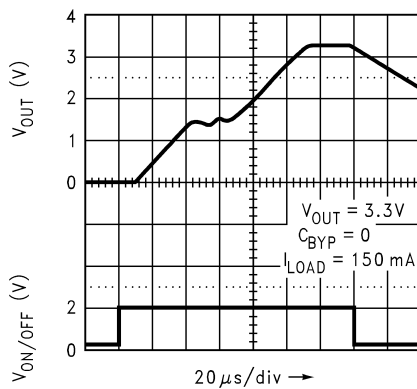
7.2.3 Application Curves (continued)



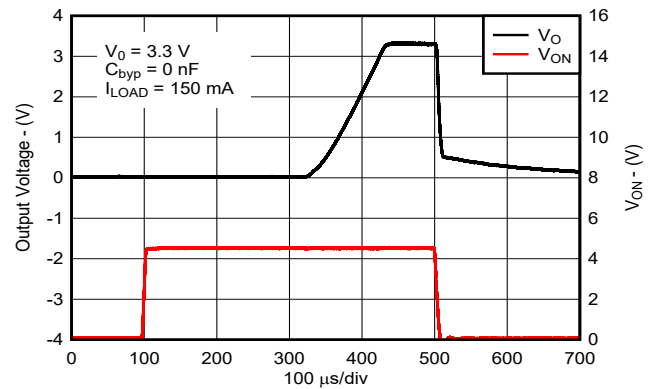
7-9. Line Transient Response for Legacy Chip



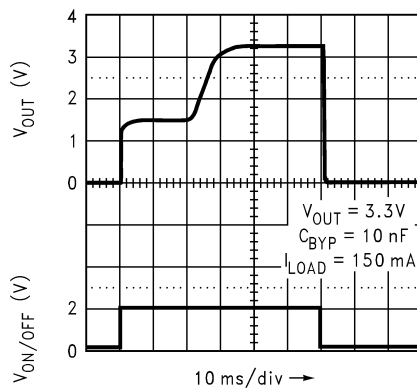
7-10. Line Transient Response for New Chip



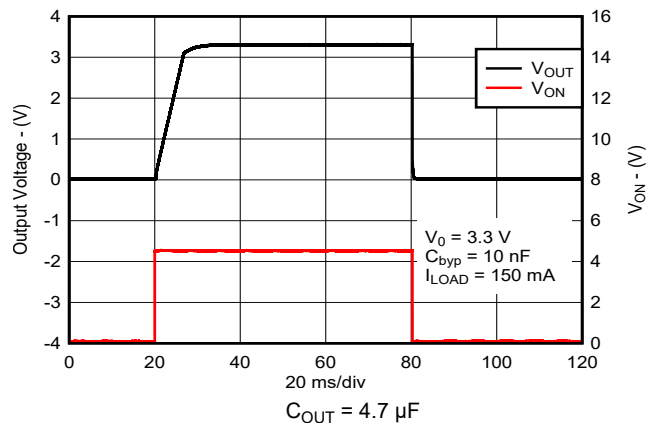
7-11. Turn-on Time for Legacy Chip



7-12. Turn-on Time for New Chip



7-13. Turn-on Time for Legacy Chip



7-14. Turn-on Time for New Chip

8 Power Supply Recommendations

A power supply can be used at the input voltage within the ranges given in the [Recommended Operating Conditions](#) table. Use bypass capacitors as described in the [セクション 9.1](#) section.

9 Layout

9.1 Layout Guidelines

- Bypass the input pin to ground with a bypass capacitor.
- The optimum placement of the bypass capacitor is closest to the V_{IN} of the device and GND of the system. Care must be taken to minimize the loop area formed by the bypass capacitor connection, the V_{IN} pin, and the GND pin of the system.
- For operation at full-rated load, use wide trace lengths to eliminate IR drop and heat dissipation.

9.2 Layout Examples

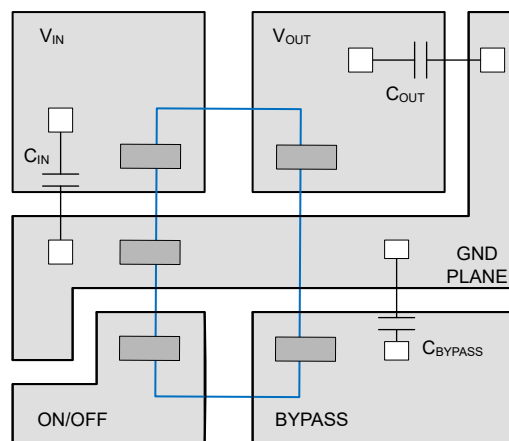


図 9-1. Layout Diagram

10 Device and Documentation Support

10.1 Device Nomenclature

表 10-1. Available Options

PRODUCT ⁽¹⁾	V _{OUT}
LP2992- xy yyz Legacy chip	xx is the nominal output voltage (for example, 33 = 3.3 V; 50 = 5.0 V). yyy is the package designator. z is the package quantity. R is for large quantity reel, T is for small quantity reel.
LP2992- xy yyz M3 New chip	xx is the nominal output voltage (for example, 33 = 3.3 V; 50 = 5.0 V). yyy is the package designator. z is the package quantity. R is for large quantity reel, T is for small quantity reel. M3 is a suffix designator for newer chip redesigns, fabricated on the latest TI process technology.

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or visit the device product folder at www.ti.com.

10.2 Documentation Support

10.2.1 Related Documentation

For related documentation see the following:

- Texas Instruments, [AN-1187 Leadless Leadframe Package \(LLP\)](#), application note
- Texas Instruments, [Semiconductor and IC Package Thermal Metrics](#), application note
- Texas Instruments, [Using New Thermal Metrics](#), application note
- Texas Instruments, [Thermal Characteristics of Linear and Logic Packages Using JEDEC PCB Designs](#), application note

10.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

10.4 サポート・リソース

テキサス・インスツルメンツ E2E™ サポート・フォーラムは、エンジニアが検証済みの回答と設計に関するヒントをエキスパートから迅速かつ直接得ることができる場所です。既存の回答を検索したり、独自の質問をしたりすることで、設計に必要な支援を迅速に得ることができます。

リンクされているコンテンツは、各寄稿者により「現状のまま」提供されるものです。これらはテキサス・インスツルメンツの仕様を構成するものではなく、必ずしもテキサス・インスツルメンツの見解を反映したものではありません。テキサス・インスツルメンツの[使用条件](#)を参照してください。

10.5 Trademarks

テキサス・インスツルメンツ E2E™ is a trademark of Texas Instruments.

すべての商標は、それぞれの所有者に帰属します。

10.6 静電気放電に関する注意事項



この IC は、ESD によって破損する可能性があります。テキサス・インスツルメンツは、IC を取り扱う際には常に適切な注意を払うことを推奨します。正しい取り扱いおよび設置手順に従わない場合、デバイスを破損するおそれがあります。

ESD による破損は、わずかな性能低下からデバイスの完全な故障まで多岐にわたります。精密な IC の場合、パラメータがわずかに変化するだけで公表されている仕様から外れる可能性があるため、破損が発生しやすくなっています。

10.7 用語集

テキサス・インスツルメンツ用語集

この用語集には、用語や略語の一覧および定義が記載されています。

11 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

Changes from Revision J (January 2017) to Revision K (December 2023)	Page
• 文書全体にわたって表、図、相互参照の採番方法を更新.....	1
• 現在のファミリのフォーマットに合わせてドキュメント全体を変更.....	1
• ドキュメントに M3 デバイスを追加.....	1
• 文書全体にわたって表、図、相互参照の採番方法を更新.....	1
• Updated Absolute Maximum Ratings, Recommended Operating Conditions, Electrical Characteristics and Thermal Information for M3-suffix(new chip).....	5
• Added <i>Device Nomenclature</i> section.....	29

Changes from Revision I (November 2015) to Revision J (January 2017)	Page
• 「概略回路」図のコンデンサから具体的な値を削除	1
• Added <i>Receiving Notification of Documentation Updates</i>	29

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
LP2992AILD-1.5/NOPB	ACTIVE	WSON	NGD	6	1000	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 125	L011A	Samples
LP2992AILD-1.8/NOPB	ACTIVE	WSON	NGD	6	1000	RoHS & Green	NIPDAU SN	Level-3-260C-168 HR	-40 to 125	L012A	Samples
LP2992AILD-3.3/NOPB	ACTIVE	WSON	NGD	6	1000	RoHS & Green	NIPDAU SN	Level-3-260C-168 HR	-40 to 125	L014A	Samples
LP2992AILD-5.0/NOPB	ACTIVE	WSON	NGD	6	1000	RoHS & Green	NIPDAU SN	Level-3-260C-168 HR	-40 to 125	L015A	Samples
LP2992AILD-3.3/NOPB	ACTIVE	WSON	NGD	6	4500	RoHS & Green	NIPDAU SN	Level-3-260C-168 HR	-40 to 125	L014A	Samples
LP2992AILD-5.0/NOPB	ACTIVE	WSON	NGD	6	4500	RoHS & Green	NIPDAU SN	Level-3-260C-168 HR	-40 to 125	L015A	Samples
LP2992AIM5-1.5/NOPB	ACTIVE	SOT-23	DBV	5	1000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFBA	Samples
LP2992AIM5-1.8/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFCA	Samples
LP2992AIM5-2.5/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFDA	Samples
LP2992AIM5-3.3/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFEA	Samples
LP2992AIM5-5.0/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFFA	Samples
LP2992AIM5X-1.5/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFBA	Samples
LP2992AIM5X-1.8/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFCA	Samples
LP2992AIM5X-2.5/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFDA	Samples
LP2992AIM5X-3.3/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFEA	Samples
LP2992AIM5X-5.0/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFFA	Samples
LP2992ILD-1.8/NOPB	ACTIVE	WSON	NGD	6	1000	RoHS & Green	NIPDAU SN	Level-3-260C-168 HR	-40 to 125	L012A B	Samples
LP2992ILD-2.5/NOPB	ACTIVE	WSON	NGD	6	1000	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 125	L013A B	Samples
LP2992ILD-3.3/NOPB	ACTIVE	WSON	NGD	6	1000	RoHS & Green	NIPDAU SN	Level-3-260C-168 HR	-40 to 125	L014A B	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
LP2992ILD-5.0/NOPB	ACTIVE	WSON	NGD	6	1000	RoHS & Green	NIPDAU SN	Level-3-260C-168 HR	-40 to 125	L015A B	Samples
LP2992ILDX-1.5/NOPB	ACTIVE	WSON	NGD	6	4500	RoHS & Green	NIPDAU SN	Level-3-260C-168 HR	-40 to 125	L011A B	Samples
LP2992ILDX-3.3/NOPB	ACTIVE	WSON	NGD	6	4500	RoHS & Green	NIPDAU SN	Level-3-260C-168 HR	-40 to 125	L014A B	Samples
LP2992ILDX-5.0/NOPB	ACTIVE	WSON	NGD	6	4500	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 125	L015A B	Samples
LP2992IM5-1.5/NOPB	ACTIVE	SOT-23	DBV	5	1000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFBB	Samples
LP2992IM5-1.8/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFGB	Samples
LP2992IM5-2.5/NOPB	ACTIVE	SOT-23	DBV	5	1000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFDB	Samples
LP2992IM5-3.0/NOPB	ACTIVE	SOT-23	DBV	5	1000	RoHS & Green	SN	Level-1-260C-UNLIM		LF8B	Samples
LP2992IM5-3.3/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFEB	Samples
LP2992IM5-5.0/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFGB	Samples
LP2992IM5X-1.5/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFBB	Samples
LP2992IM5X-1.8/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFGB	Samples
LP2992IM5X-2.5/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFDB	Samples
LP2992IM5X-3.3/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFEB	Samples
LP2992IM5X-5.0/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LFGB	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of ≤ 1000 ppm threshold. Antimony trioxide based flame retardants must also meet the ≤ 1000 ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LP2992AILD-1.5/NOPB	WSO	NGD	6	1000	178.0	12.4	3.6	3.2	1.0	8.0	12.0	Q1
LP2992AILD-1.8/NOPB	WSO	NGD	6	1000	178.0	12.4	3.6	3.2	1.0	8.0	12.0	Q1
LP2992AILD-3.3/NOPB	WSO	NGD	6	1000	178.0	12.4	3.6	3.2	1.0	8.0	12.0	Q1
LP2992AILD-5.0/NOPB	WSO	NGD	6	1000	180.0	12.4	3.6	3.2	1.0	8.0	12.0	Q1
LP2992AILD-3.3/NOPB	WSO	NGD	6	4500	330.0	12.4	3.6	3.2	1.0	8.0	12.0	Q1
LP2992AILD-5.0/NOPB	WSO	NGD	6	4500	330.0	12.4	3.6	3.2	1.0	8.0	12.0	Q1
LP2992AIM5-1.5/NOPB	SOT-23	DBV	5	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992AIM5-1.8/NOPB	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992AIM5-1.8/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992AIM5-2.5/NOPB	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992AIM5-2.5/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992AIM5-3.3/NOPB	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992AIM5-3.3/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992AIM5-5.0/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992AIM5X-1.5/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992AIM5X-1.8/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LP2992AIM5X-2.5/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992AIM5X-3.3/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992AIM5X-3.3/NOPB	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992AIM5X-5.0/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992AIM5X-5.0/NOPB	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992ILD-1.8/NOPB	WSO	NGD	6	1000	178.0	12.4	3.6	3.2	1.0	8.0	12.0	Q1
LP2992ILD-2.5/NOPB	WSO	NGD	6	1000	178.0	12.4	3.6	3.2	1.0	8.0	12.0	Q1
LP2992ILD-3.3/NOPB	WSO	NGD	6	1000	178.0	12.4	3.6	3.2	1.0	8.0	12.0	Q1
LP2992ILD-5.0/NOPB	WSO	NGD	6	1000	180.0	12.4	3.6	3.2	1.0	8.0	12.0	Q1
LP2992ILD-1.5/NOPB	WSO	NGD	6	4500	330.0	12.4	3.6	3.2	1.0	8.0	12.0	Q1
LP2992ILD-3.3/NOPB	WSO	NGD	6	4500	330.0	12.4	3.6	3.2	1.0	8.0	12.0	Q1
LP2992ILD-5.0/NOPB	WSO	NGD	6	4500	330.0	12.4	3.6	3.2	1.0	8.0	12.0	Q1
LP2992IM5-1.5/NOPB	SOT-23	DBV	5	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992IM5-1.8/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992IM5-1.8/NOPB	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992IM5-2.5/NOPB	SOT-23	DBV	5	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992IM5-3.0/NOPB	SOT-23	DBV	5	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992IM5-3.3/NOPB	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992IM5-3.3/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992IM5-5.0/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992IM5X-1.5/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992IM5X-1.8/NOPB	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992IM5X-1.8/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992IM5X-2.5/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992IM5X-3.3/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992IM5X-3.3/NOPB	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992IM5X-5.0/NOPB	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP2992IM5X-5.0/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3

TAPE AND REEL BOX DIMENSIONS

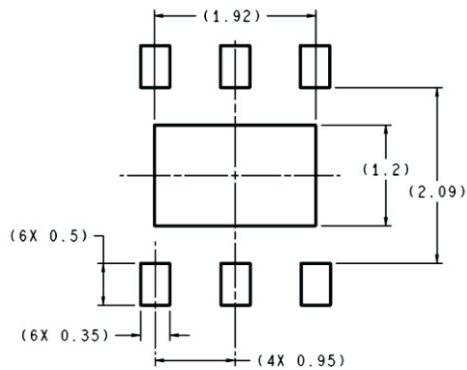


*All dimensions are nominal

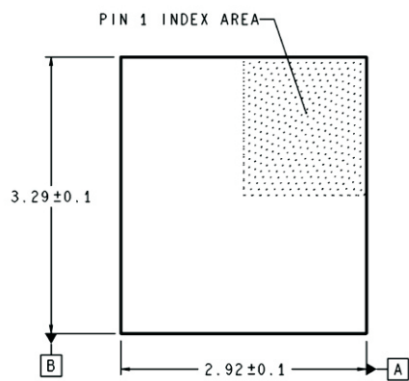
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LP2992AILD-1.5/NOPB	WSO	NGD	6	1000	208.0	191.0	35.0
LP2992AILD-1.8/NOPB	WSO	NGD	6	1000	208.0	191.0	35.0
LP2992AILD-3.3/NOPB	WSO	NGD	6	1000	208.0	191.0	35.0
LP2992AILD-5.0/NOPB	WSO	NGD	6	1000	213.0	191.0	35.0
LP2992AILD-3.3/NOPB	WSO	NGD	6	4500	356.0	356.0	36.0
LP2992AILD-5.0/NOPB	WSO	NGD	6	4500	356.0	356.0	36.0
LP2992AIM5-1.5/NOPB	SOT-23	DBV	5	1000	208.0	191.0	35.0
LP2992AIM5-1.8/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP2992AIM5-1.8/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LP2992AIM5-2.5/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP2992AIM5-2.5/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LP2992AIM5-3.3/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP2992AIM5-3.3/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LP2992AIM5-5.0/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LP2992AIM5X-1.5/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LP2992AIM5X-1.8/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LP2992AIM5X-2.5/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LP2992AIM5X-3.3/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LP2992AIM5X-3.3/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP2992AIM5X-5.0/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LP2992AIM5X-5.0/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP2992ILD-1.8/NOPB	WSO	NGD	6	1000	208.0	191.0	35.0
LP2992ILD-2.5/NOPB	WSO	NGD	6	1000	208.0	191.0	35.0
LP2992ILD-3.3/NOPB	WSO	NGD	6	1000	208.0	191.0	35.0
LP2992ILD-5.0/NOPB	WSO	NGD	6	1000	213.0	191.0	35.0
LP2992ILD-1.5/NOPB	WSO	NGD	6	4500	367.0	367.0	38.0
LP2992ILD-3.3/NOPB	WSO	NGD	6	4500	356.0	356.0	36.0
LP2992ILD-5.0/NOPB	WSO	NGD	6	4500	356.0	356.0	36.0
LP2992IM5-1.5/NOPB	SOT-23	DBV	5	1000	208.0	191.0	35.0
LP2992IM5-1.8/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LP2992IM5-1.8/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP2992IM5-2.5/NOPB	SOT-23	DBV	5	1000	208.0	191.0	35.0
LP2992IM5-3.0/NOPB	SOT-23	DBV	5	1000	208.0	191.0	35.0
LP2992IM5-3.3/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP2992IM5-3.3/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LP2992IM5-5.0/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LP2992IM5X-1.5/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LP2992IM5X-1.8/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP2992IM5X-1.8/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LP2992IM5X-2.5/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LP2992IM5X-3.3/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LP2992IM5X-3.3/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP2992IM5X-5.0/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP2992IM5X-5.0/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0

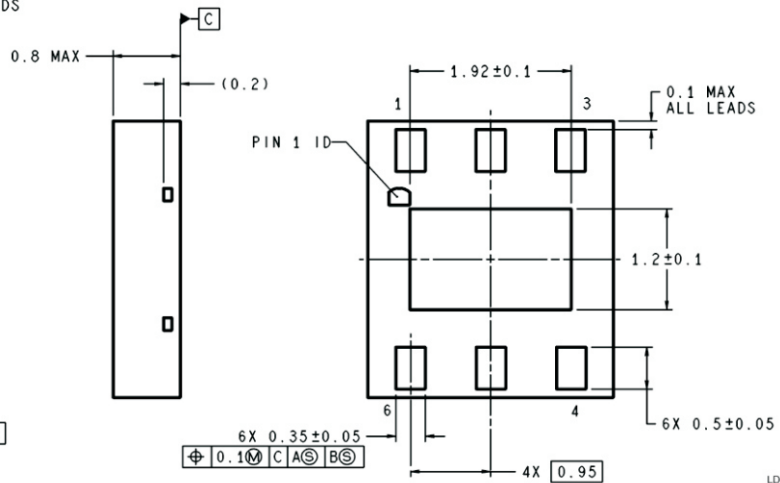
NGD0006A



RECOMMENDED LAND PATTERN
1:1 RATIO WITH PKG SOLDER PADS



DIMENSIONS ARE IN MILLIMETERS



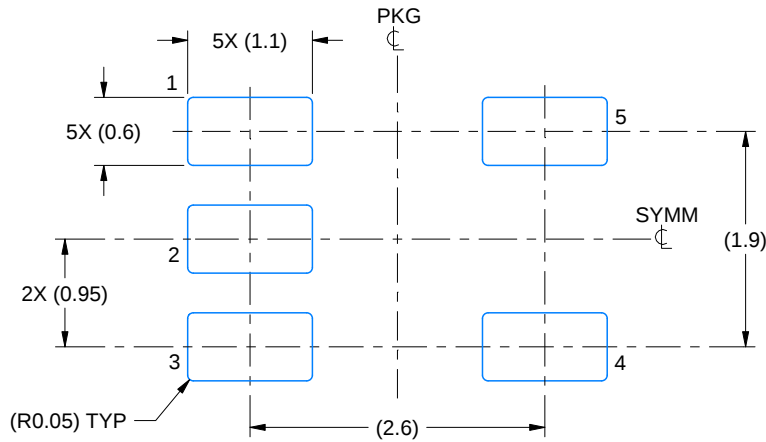
LDE06A (Rev A)

EXAMPLE BOARD LAYOUT

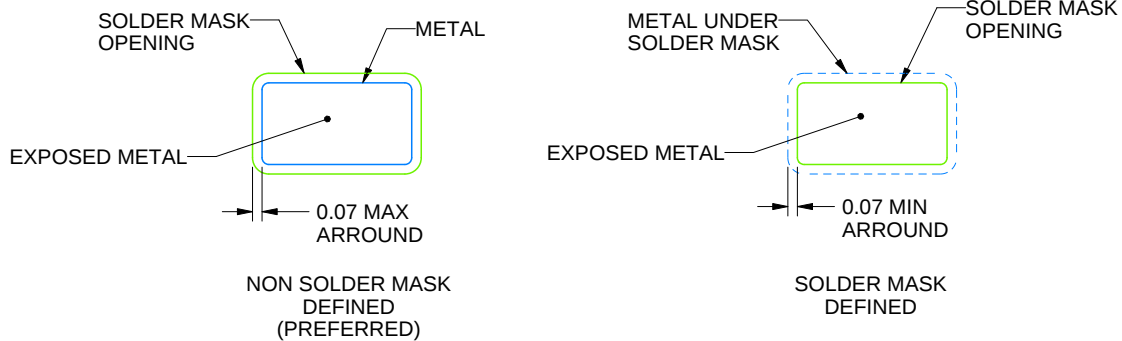
DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



SOLDER MASK DETAILS

4214839/J 02/2024

NOTES: (continued)

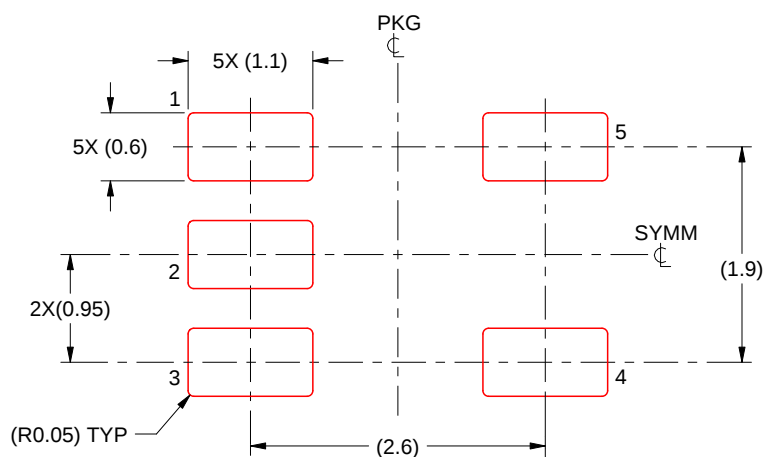
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

4214839/J 02/2024

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

重要なお知らせと免責事項

TI は、技術データと信頼性データ (データシートを含みます)、設計リソース (リファレンス・デザインを含みます)、アプリケーションや設計に関する各種アドバイス、Web ツール、安全性情報、その他のリソースを、欠陥が存在する可能性のある「現状のまま」提供しており、商品性および特定目的に対する適合性の黙示保証、第三者の知的財産権の非侵害保証を含むいかなる保証も、明示的または黙示的にかかわらず拒否します。

これらのリソースは、TI 製品を使用する設計の経験を積んだ開発者への提供を意図したものです。(1) お客様のアプリケーションに適した TI 製品の選定、(2) お客様のアプリケーションの設計、検証、試験、(3) お客様のアプリケーションに該当する各種規格や、その他のあらゆる安全性、セキュリティ、規制、または他の要件への確実な適合に関する責任を、お客様のみが単独で負うものとし、TI は一切の責任を拒否します。

上記の各種リソースは、予告なく変更される可能性があります。これらのリソースは、リソースで説明されている TI 製品を使用するアプリケーションの開発の目的でのみ、TI はその使用をお客様に許諾します。これらのリソースに関して、他の目的で複製することや掲載することは禁止されています。TI や第三者の知的財産権のライセンスが付与されている訳ではありません。お客様は、これらのリソースを自身で使用した結果発生するあらゆる申し立て、損害、費用、損失、責任について、TI およびその代理人を完全に補償するものとし、TI は一切の責任を拒否します。

TI の製品は、[TI の販売条件](#)、または [ti.com](#) やかかる TI 製品の関連資料などのいずれかを通じて提供する適用可能な条項の下で提供されています。TI がこれらのリソースを提供することは、適用される TI の保証または他の保証の放棄の拡大や変更を意味するものではありません。

お客様がいかなる追加条項または代替条項を提案した場合でも、TI はそれらに異議を唱え、拒否します。

郵送先住所 : Texas Instruments, Post Office Box 655303, Dallas, Texas 75265
Copyright © 2024, Texas Instruments Incorporated